



INTERNATIONAL ATOMIC ENERGY AGENCY
UNITED NATIONS EDUCATIONAL, SCIENTIFIC AND CULTURAL ORGANIZATION
INTERNATIONAL CENTRE FOR THEORETICAL PHYSICS
I.C.T.P., P.O. BOX 586, 34100 TRIESTE, ITALY, CABLE: CENTRATOM TRIESTE



UNITED NATIONS INDUSTRIAL DEVELOPMENT ORGANIZATION



INTERNATIONAL CENTRE FOR SCIENCE AND HIGH TECHNOLOGY

c/o INTERNATIONAL CENTRE FOR THEORETICAL PHYSICS 34100 TRIESTE (ITALY) VIA GRIGNANO, 9 (ADRIATICO PALACE) P.O. BOX 586 TELEPHONE 040-224572 TELEFAX 040-224575 TELEX 460449 APH I

SMR. 628 - 26

**Research Workshop in Condensed Matter,
Atomic and Molecular Physics
(22 June - 11 September 1992)**

**Working Party on:
"Energy Transfer in Interactions with
Surfaces and Adsorbates"
(31 August - 11 September 1992)**

**"Charge Exchange in
Particle Scattering from Surfaces"**

**W. HEILAND
Universität Osnabrück
Fachbereich Physik
Postfach 4469
Barbarastrasse 7
Osnabrück D-4500
GERMANY**

These are preliminary lecture notes, intended only for distribution to participants.

Grignani
192

W. Heiland
University of Osnabrück

Charge exchange in particle
scattering from surfaces

- 1) Scattering - - channeling
- 2) Atomic particles & charge exchange
- 3) Molecular particles & charge exchange

Table 1: List of surface analysis techniques

1. Elastic scattering techniques

Acronym	Technique	Probe particle	Det. particle
EELS	Electron energy loss spectr.	Electron	Electron
HREELS	High resolution EELS	Electron	Electron
SEM	Scanning electron microscop	Electron	Electron
ISS (LEIS)	(Low energy) ion scatt. spectr.	Ion	Ion
MEIS	Medium energy ion scattering	Ion	Ion
RBS	Rutherford back scattering	Ion	Ion
ICISS	Impact collision ISS	Ion	Ion
NICISS	Neutral ICISS	Ion	Atom
ERD (DRS)	Elastic recoil detection (Direct recoil sp.)	Ion	Ion
FIM	Field ion microscopy	Atom	Ion

2. Diffraction methods

LEED	Low energy electron diffraction	Electron	Electron
RHEED	Reflection high-energy electron diffraction	Electron	Electron
HEAD	Helium atom diffraction	Atom	Atom

3. Ionisation methods

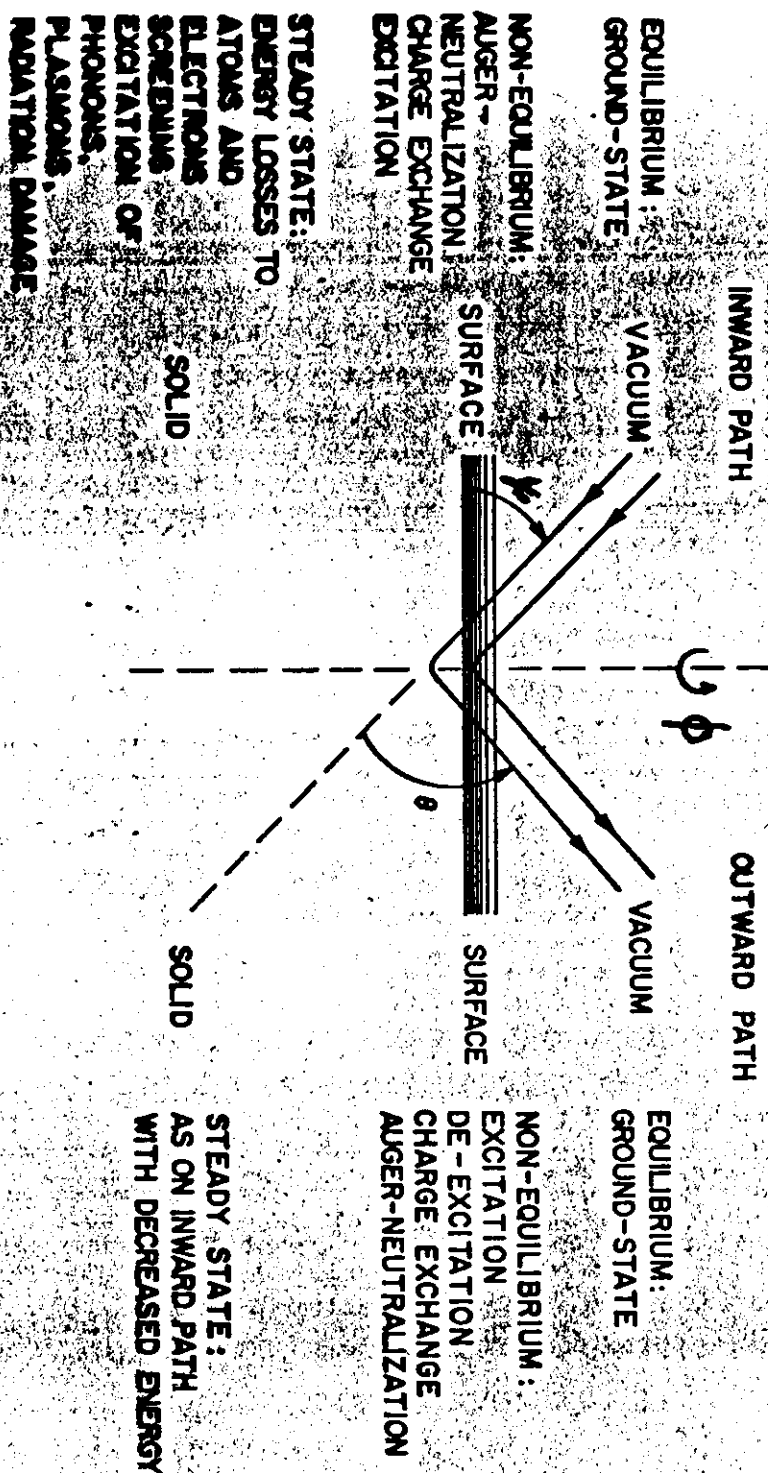
AES	Auger electron spectroscopy	Electron	Electron
AES	Photoelectron spectroscopy	Photon	Electron
ESCA	Electron spectroscopy for chemical analysis = PES.	Photon	Electron
UPS	Ultraviolet photoelectron spectroscopy	Photon	Electron
ARUPS	Angular resolved UPS	Photon	Electron
XPS	X-ray photoelectron spectr.	Photon	Electron
SEXAFS	Surface extended X-ray absorption fine structure	Photon	Electron
NEXAFS	Near edge X-ray absorption fine structure	Photon	Electron
FEM	Field electron microscopy	Field	Electron

4. Bond breaking

PSD	Photon stimulated desorption	Photon	Ion
ESD	Electron stimulated desorption	Electron	Ion
ESDIAD	ESD ion angular distribution	Electron	Ion
SIMS	Secondary ion mass spectrom.	Ion	Ion
SNMS	Secondary neutral mass spectr.	Ion	Atom
FABS	Fast atom bombardement spec.	Atom	Atom
ERD	Elastic recoil detection (Direction recoil sp.)	Ion	Ion

5. Charge exchange methods

INS	Ion neutralisation spectr.	Ion	Electron
MDS	Metastable de-excitation spectr.	Atom	Electron
STM	Scanning tunneling microscopy	(tip)	Electron



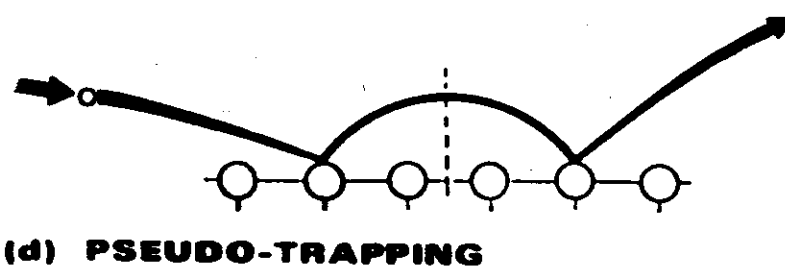
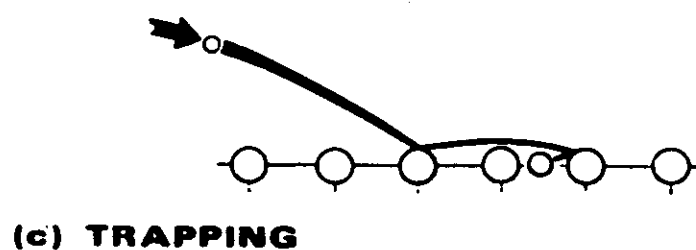
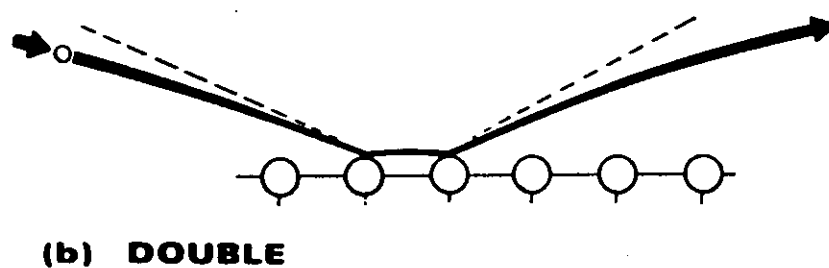
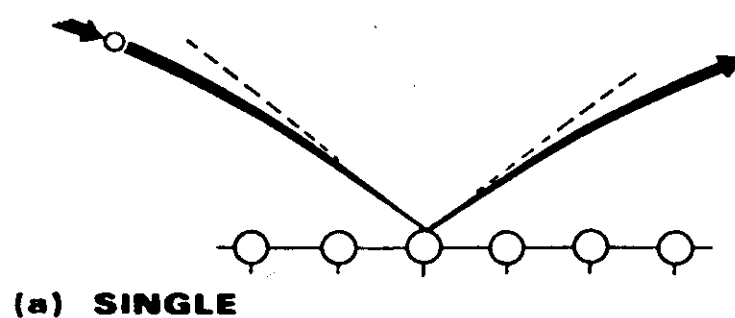
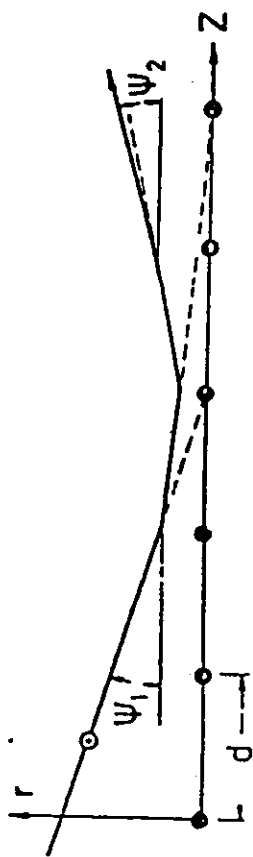
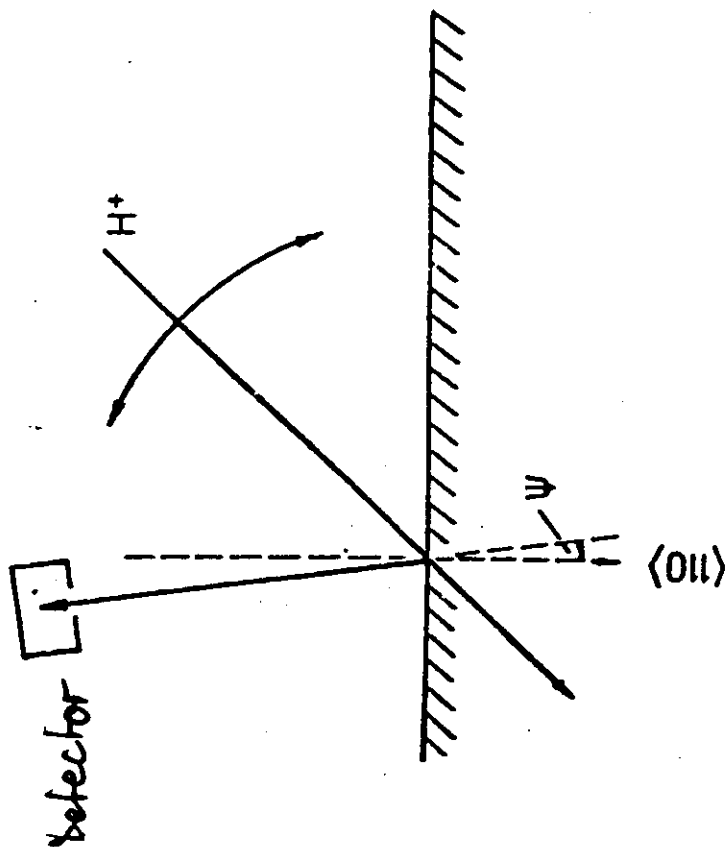
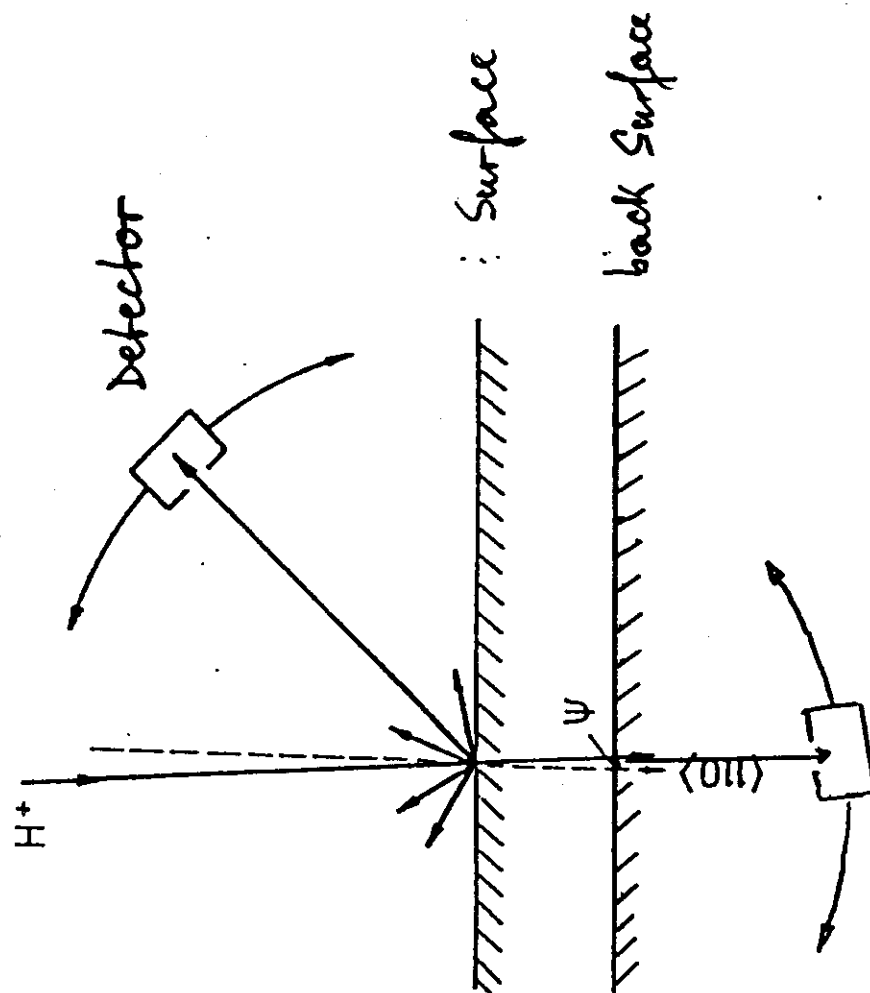
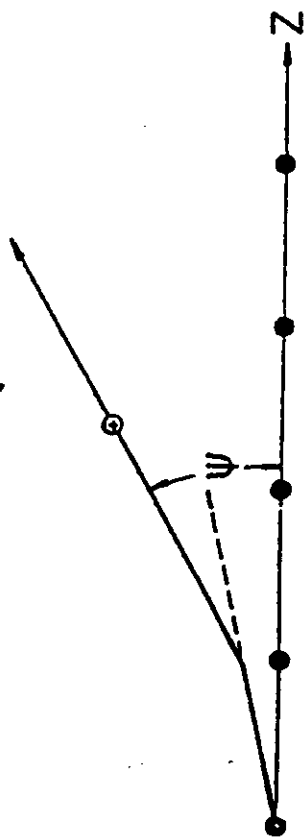


Fig. 9. Some trajectory possibilities seen in gas surface scattering.

Channeling



Blocking



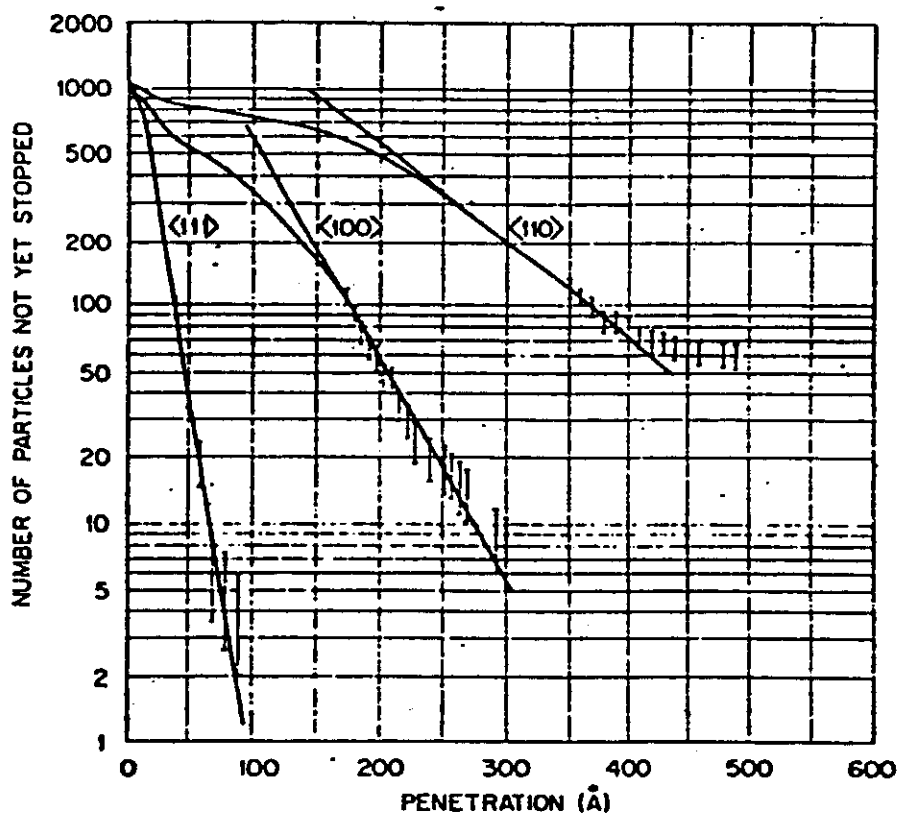
THE CHANNELING OF ENERGETIC ATOMS IN CRYSTAL LATTICES

Mark T. Robinson and O. S. Oen

Solid State Division, Oak Ridge National Laboratory¹

Oak Ridge, Tennessee

(Received 5 December 1962)



5-keV Cu Atoms Slowing Down in Cu, Born-Mayer Potential;
Static Lattice; Initial Directions as Given on Curves.

Fig. 1. Integral penetration distributions calculated for 5-keV Cu atoms slowing down in a static Cu lattice according to the Born-Mayer potential. The initial directions of the incident particles are given on the curves. The vertical bars give estimates of the statistical uncertainties in the calculations in the tail regions.

INFLUENCE OF CRYSTAL LATTICE ON MOTION OF ENERGETIC CHARGED PARTICLES.

BY

JENS LINDHARD

Classical Rutherford shadow behind one atom

A simple and illustrative phenomenon is the shadow behind a repul-
scattering centre in an external, parallel beam of particles. The scatter-
is assumed to be classical (cf. (B.4) and (B.5)), and we suppose that it
is a screen perpendicular to the beam, at a distance d behind the scatter-
centre. This idealized experiment may be said to represent a pair of at-
the scattering centre being one atom, the second atom being placed in
screen, so that we ask for the probability of hitting the second atom.

An example of nearly isolated atomic pairs is found e.g. for ne-
ighbours in the diamond lattice, i.e. in the $\langle 111 \rangle$ -direction. Such a
may also be regarded as incomplete strings, with successively two occu-
and to unoccupied sites. The pair effect can occur not merely in a
atomic substance like Si, but also in e.g. ZnS, where all S atoms are shir-
by Zn atoms in one direction, and conversely in the opposite direction.

For simplicity, we consider merely Rutherford scattering, corresponding
to impact parameters $p \leq a$. Let the scattering centre be placed on the
 z -axis, the beam being parallel to this axis. A particle with impact para-
meter p hits the screen at a distance r from the z -axis, and for small angles
of deflection r is given by

$$r = p + \frac{b}{p}d, \quad (2.11)$$

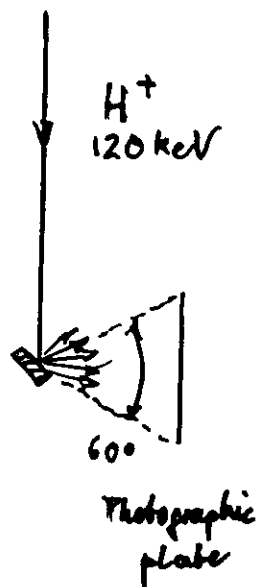
where $b = Z_1 Z_2 e^2 / E$. The distance r has a minimum, $r_{\min} = 2\sqrt{bd}$, for
 $p = \sqrt{bd}$. The shadow region therefore has a parabolic shape, as a function
of the distance d , since its edge is at $r = r_{\min} = d^{1/2}$.

In order to hit the centre of the screen, we must tilt the beam by an
angle $\varphi_{\min} = 2\sqrt{b/d} = \varphi_1/\sqrt{2}$, where φ_1 is given by (2.9). The intensity
distribution on the screen is easily obtained from (2.11). Let $f(r)$ be the
intensity on the screen, the external beam containing one particle per unit
area. Then, for large r , $f(r)$ tends to unity, whereas $f(r) = 0$ for $r < r_{\min}$.
The particles aiming at $r < r_{\min}$ are pushed just outside $r_{\min}$, where $f(r)$
has a peak. In fact,

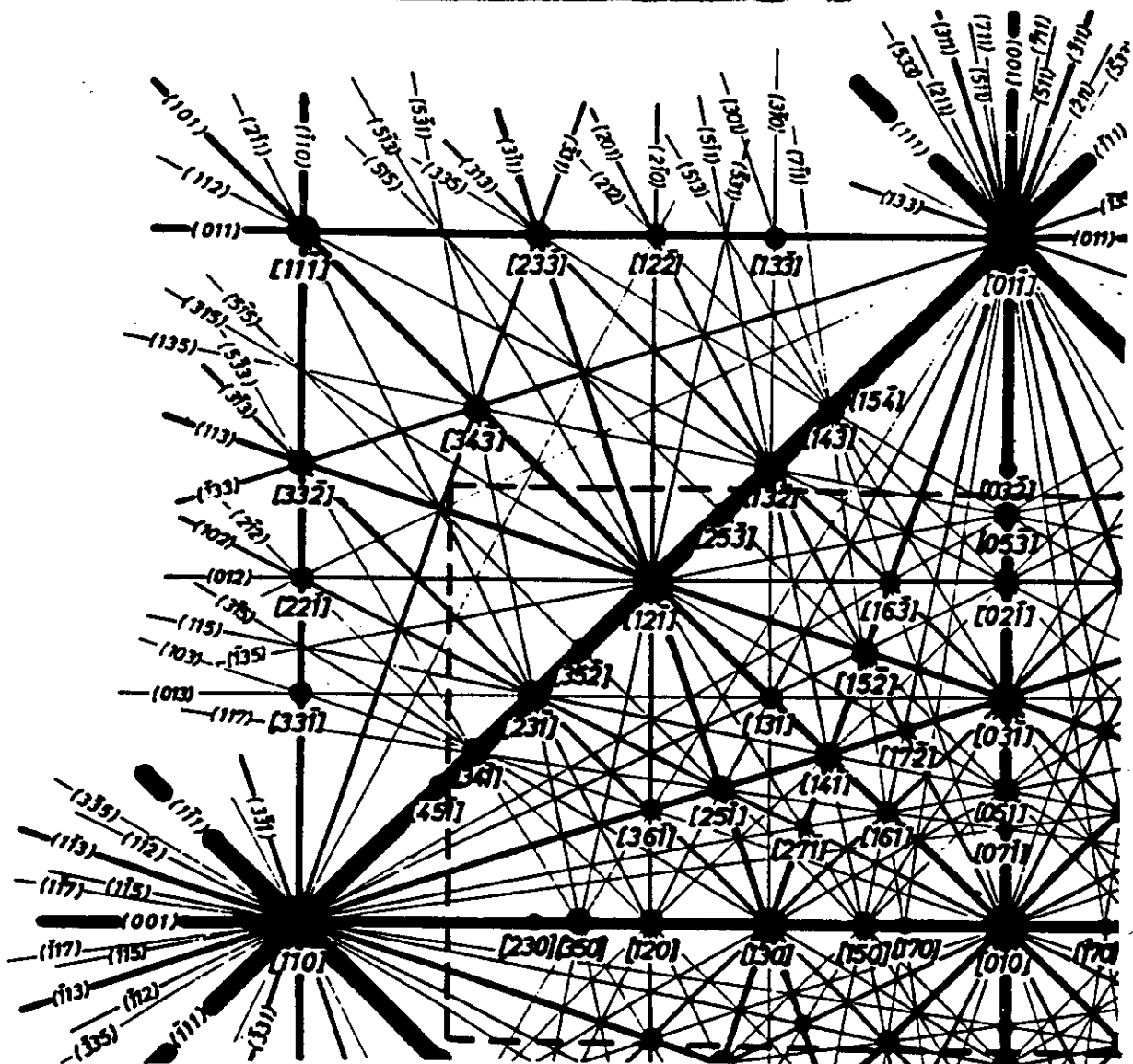
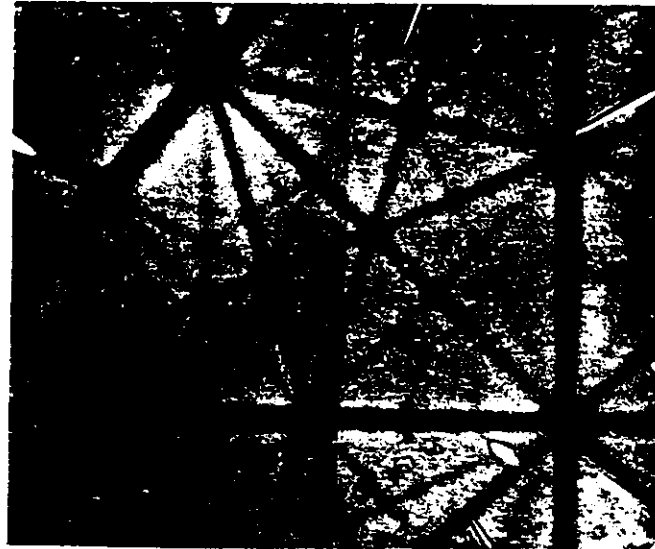
$$f(r) = \begin{cases} 0, & r < r_{\min} \\ \frac{1}{2} \left[\left(1 - \frac{r_{\min}^2}{r^2} \right)^{1/2} + \left(1 - \frac{r_{\min}^2}{r^2} \right)^{-1/2} \right], & r > r_{\min} \end{cases} \quad (2.12)$$

The sharp edge at $r = r_{\min}$ is blurred when quantal corrections are taken
into account, the blurring remaining small only when $\kappa = 2Z_1 Z_2 u_0 / v$ is
large compared to unity (cf. (2.29)).

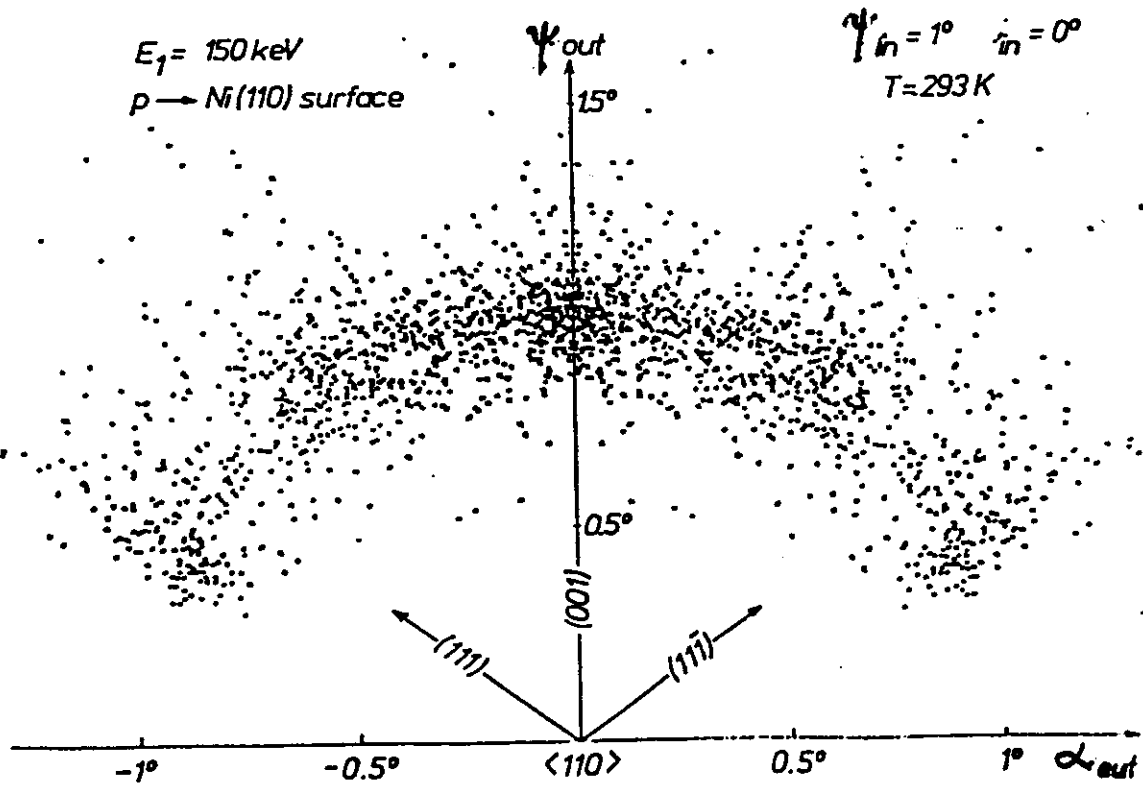
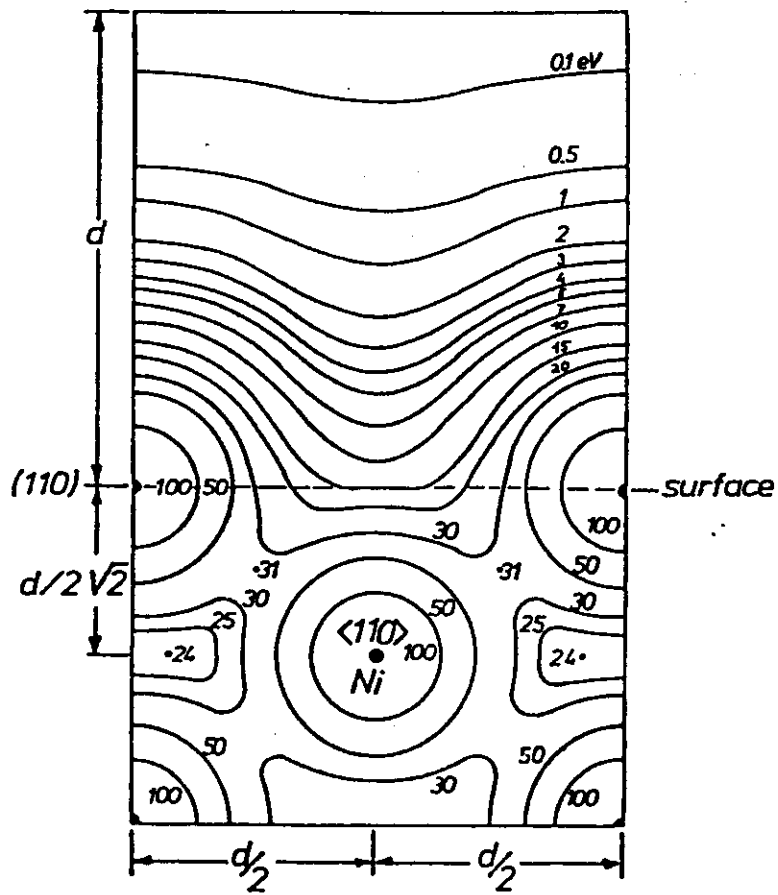
The number of particles missing on the screen inside $r_{\min}$ is $\pi r_{\min}^2$.
The number missing inside r is $\pi r^2 - \int_{r_{\min}}^r 2\pi r dr f(r) = \pi r^2 (1 - (1 - r_{\min}^2/r^2)^{1/2})$.
For large r this implies that only half the missing number is compensated
in Rutherford scattering with $p \ll d$. It is easy to show that, for screened
atomic fields, the full compensation occurs for r larger than a . In fact, when
(2.6') holds, a 75 per cent compensation is obtained for $r \sim Ca$. Thus, for
fast particles obeying eq. (2.9') the compensation is divided in two equal
parts, one occurring at $r \geq 2(bd)^{1/2}$, or $\varphi \geq \varphi_1/\sqrt{2}$, and the other at $r \sim Ca$,
or $\varphi \sim Ca/d$.



R. Behrisch
1968

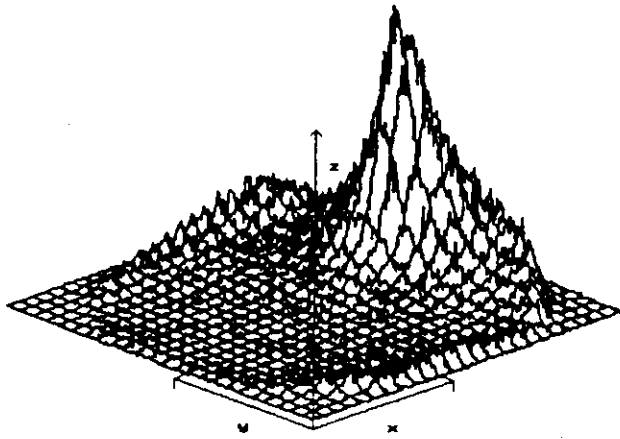


oben: Photographische Aufnahme der von einem Cu-Einkristall zurückgestreuten Wasserstoffatome. $E_1 = 120 \text{ keV}$, die Photoplate war empfindlich für $E > 60 \text{ keV}$.
unten: Gnomonische Projektion eines kfz-Gitters in $[010]$ -Richtung. Der Ausschnitt der photographischen Aufnahme ist eingezeichnet.

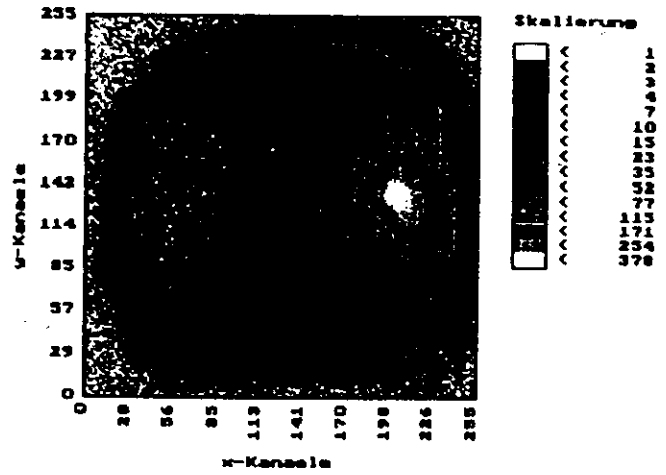


90060808

(1x1) CO - Präparation

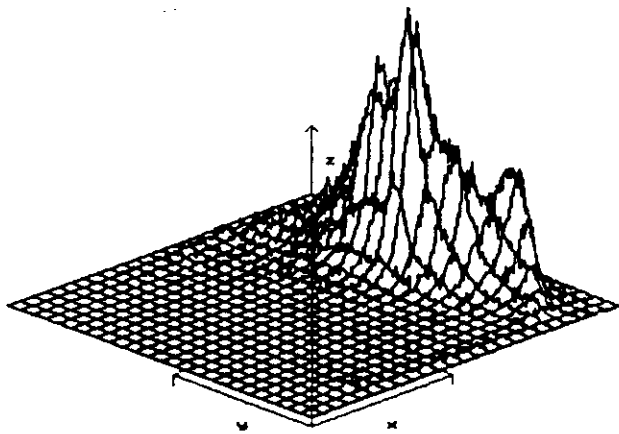


90060808

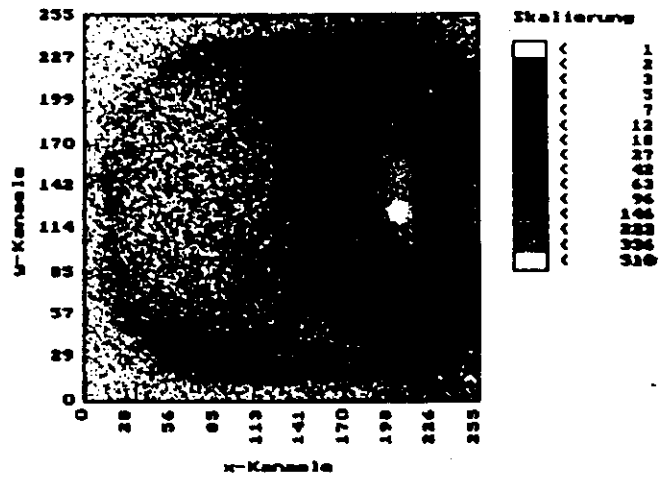


90060806

(1x1) O₂ - Präparation

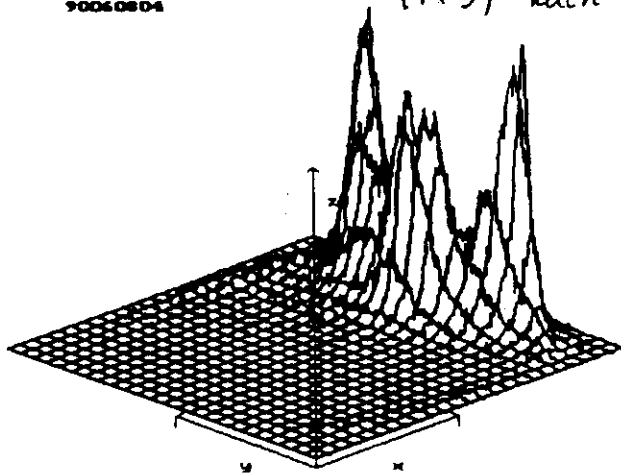


90060806

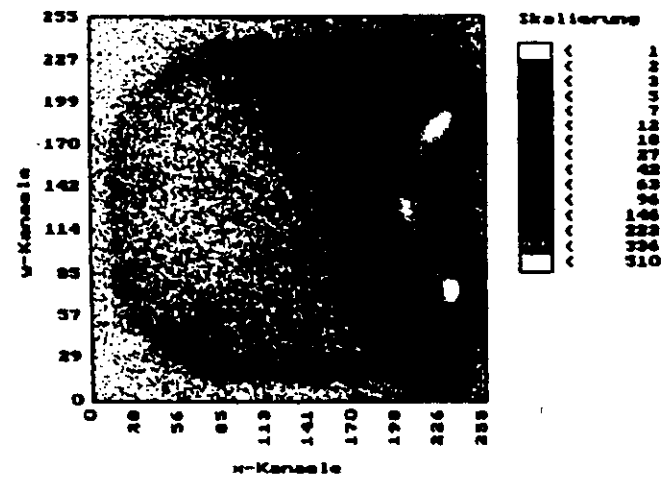


90060804

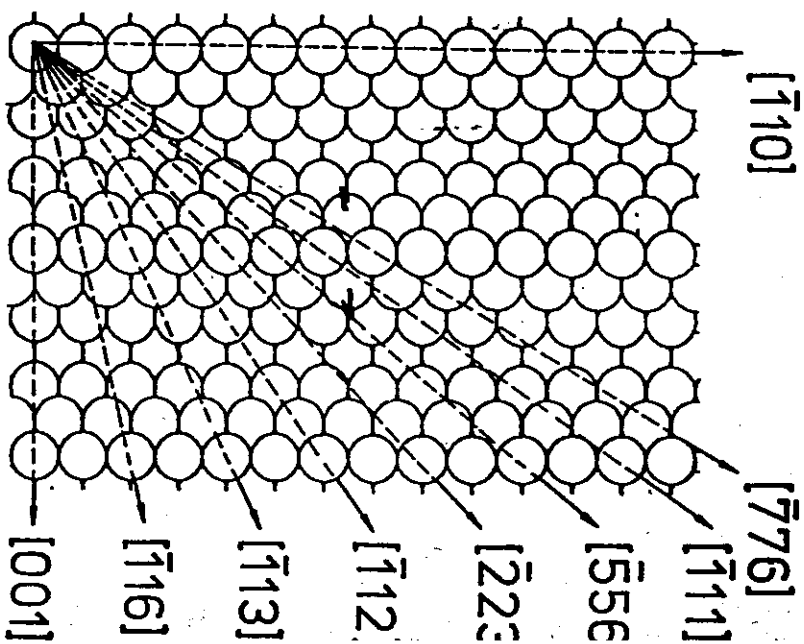
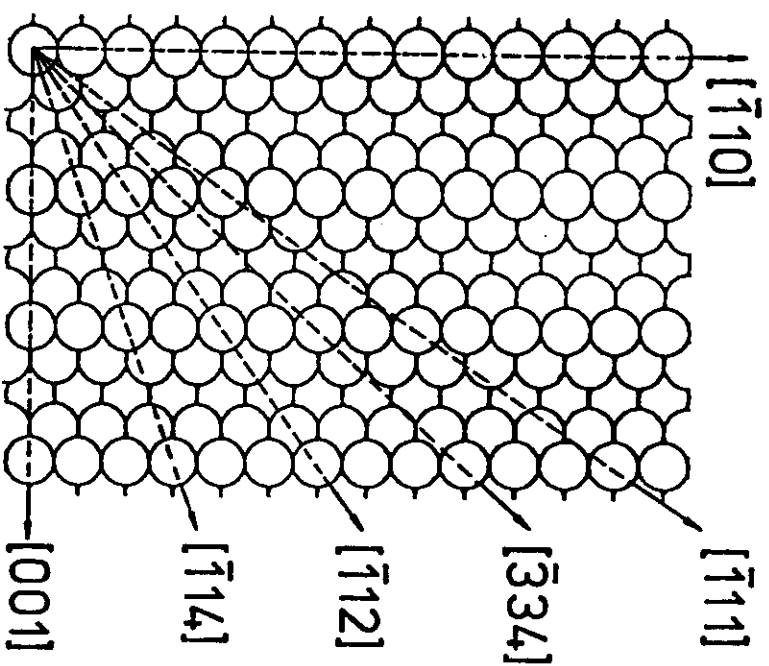
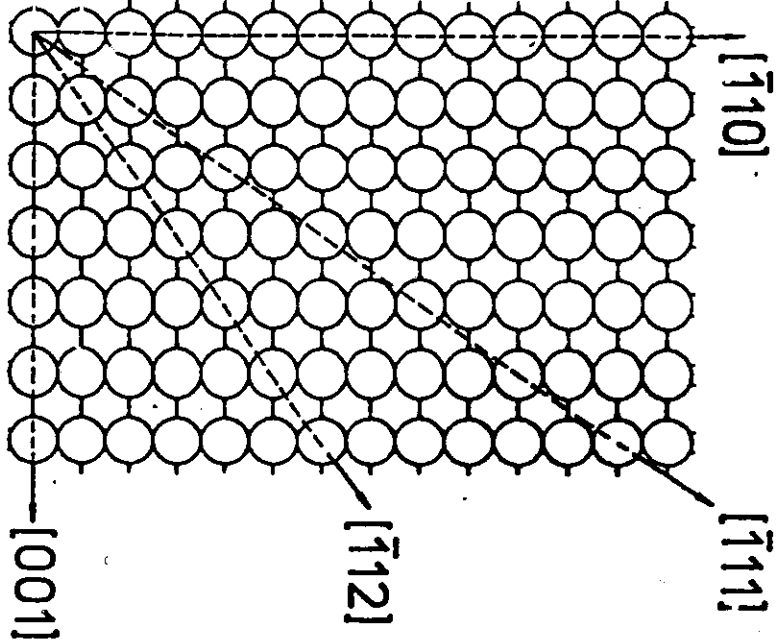
"(1x3)" nach Tempern



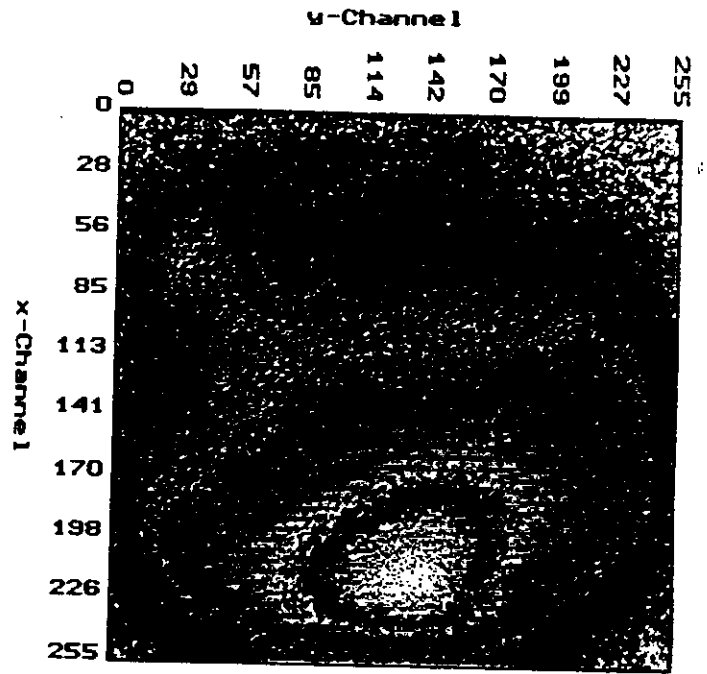
90060804



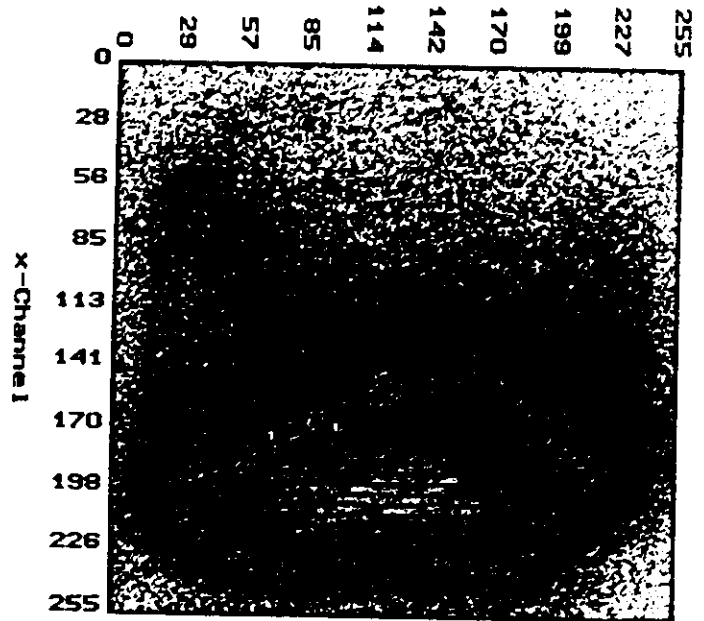
3.5 keV Ne⁺, $\gamma = 4.5^\circ$



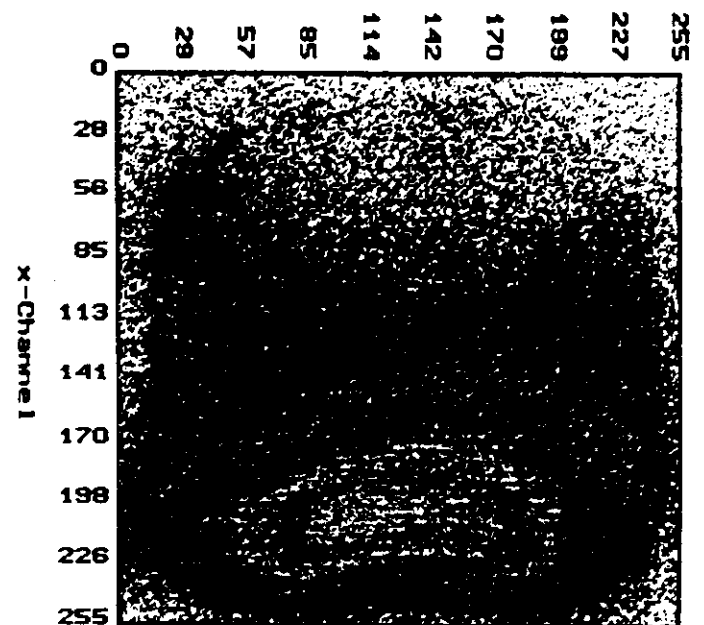
03038212



03038205



03039202

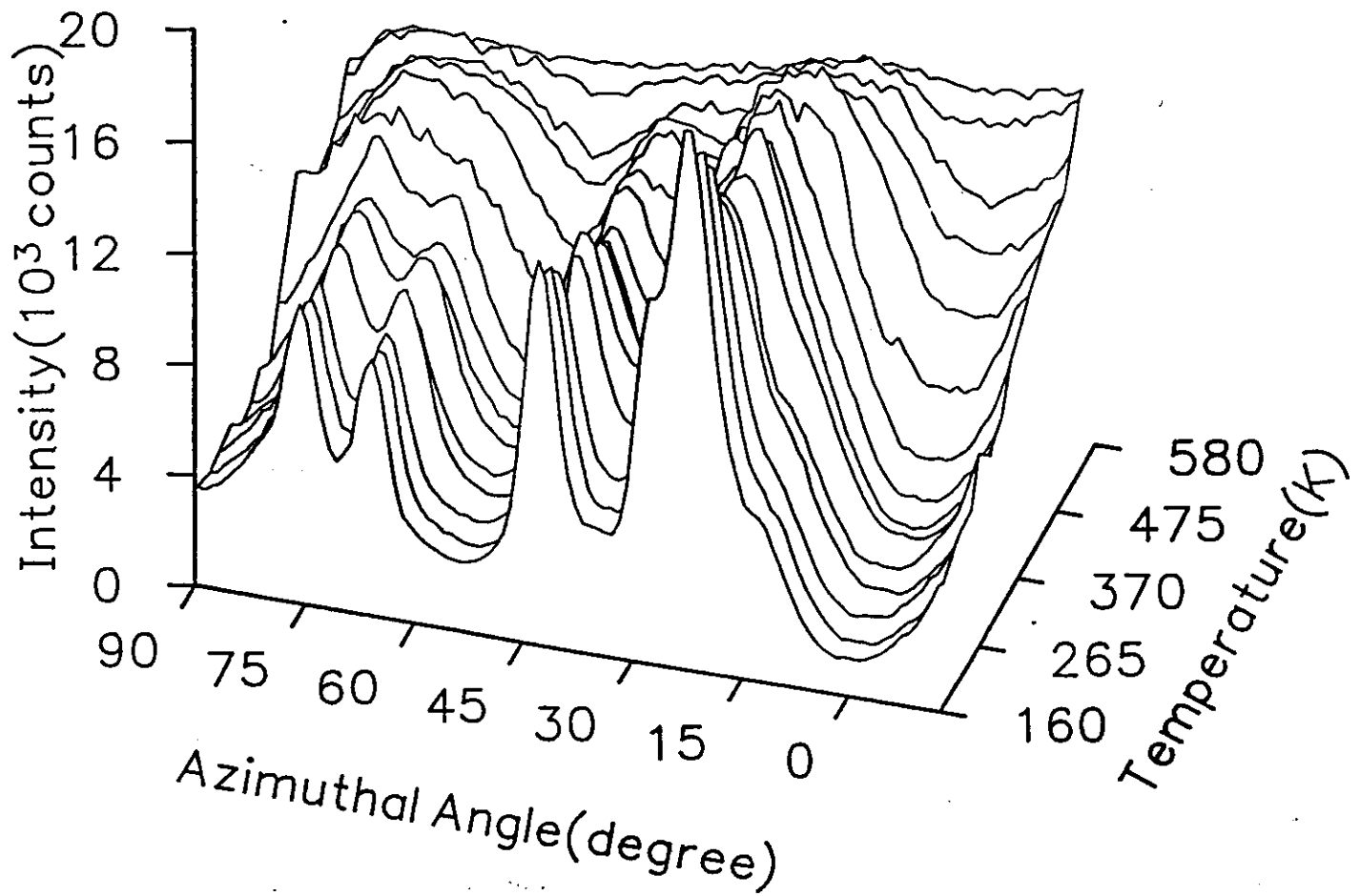


Pb(110)

S. SPELLER

1991

Phys Rev. Lett '92



1. The first step in the process of creating a new product is to identify a market need. This involves conducting market research to understand the target audience's preferences and pain points. Once a need is identified, the next step is to develop a concept that addresses this need. This often involves brainstorming sessions with a team of designers and engineers. The concept is then refined through prototyping and testing, ensuring it meets the market requirements. Finally, the product is launched into the market, with ongoing monitoring and feedback loops to ensure its success and make necessary improvements.



stellbarer Spalt, (8) Probe, (9) Analysator, (10) Detektor

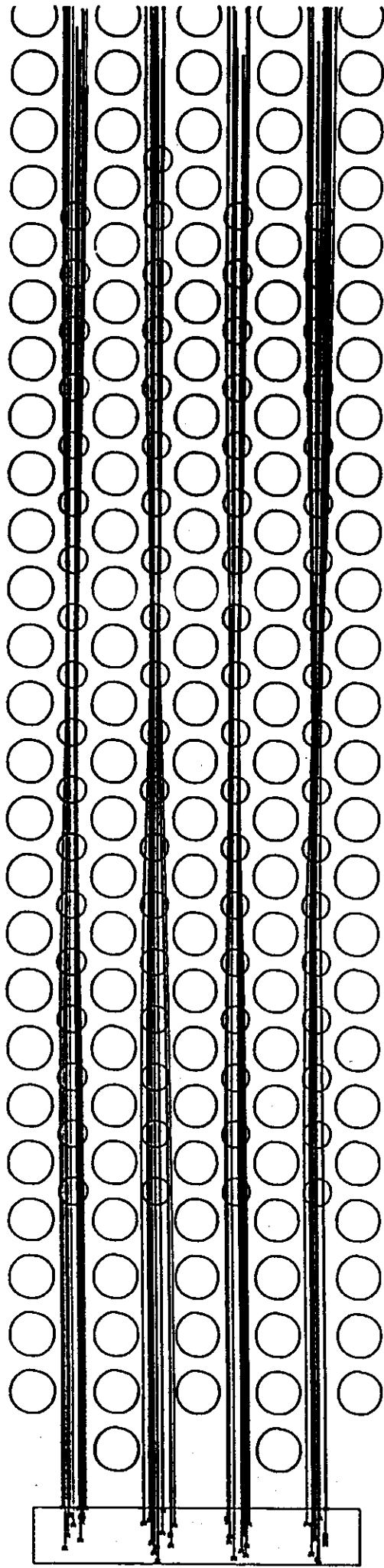
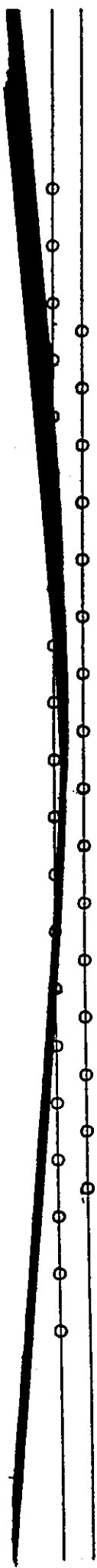
H. Gertis 189 MARLOWE (M.T. Robinson, D.S. den)

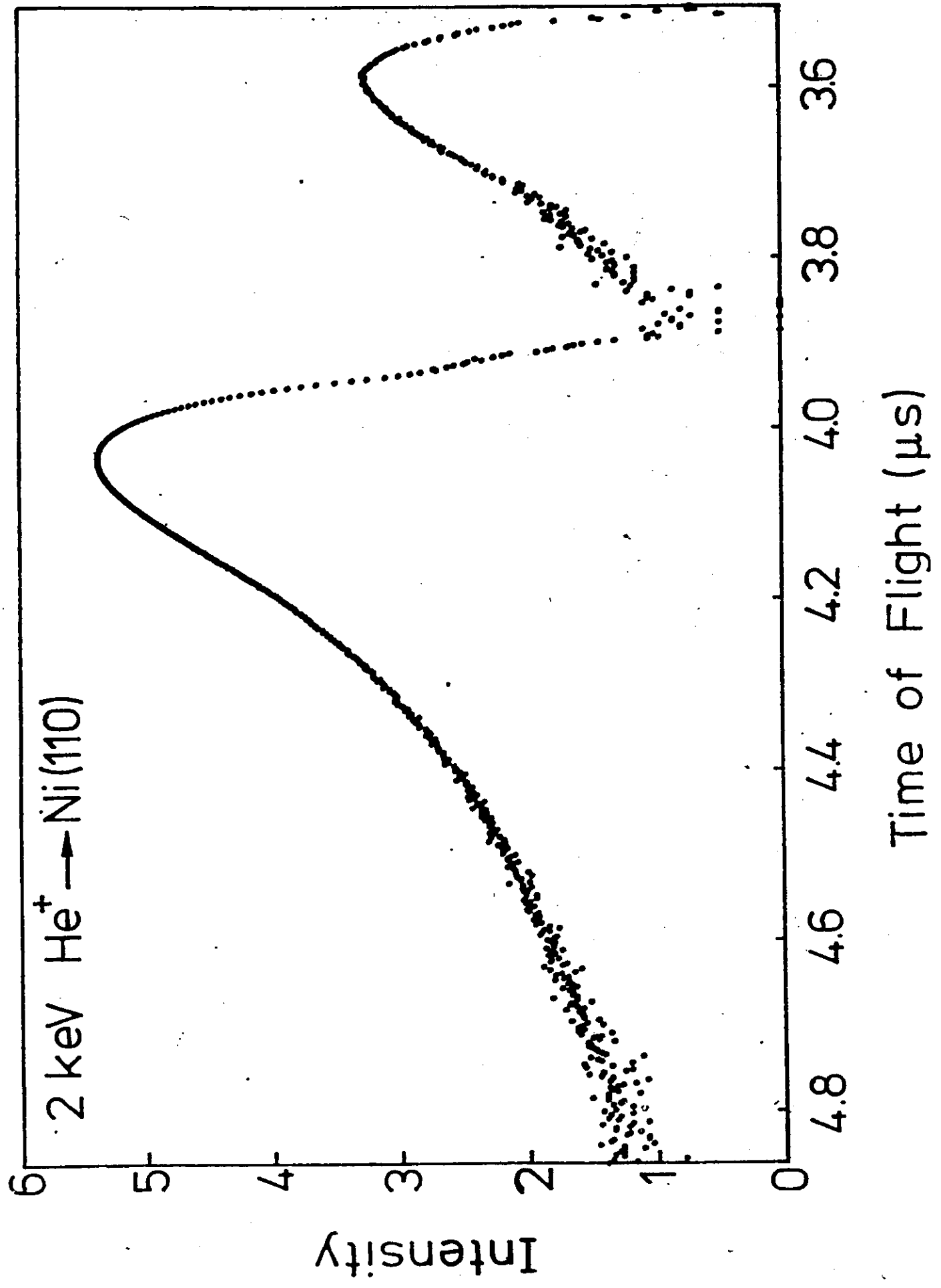
v. d. 05.

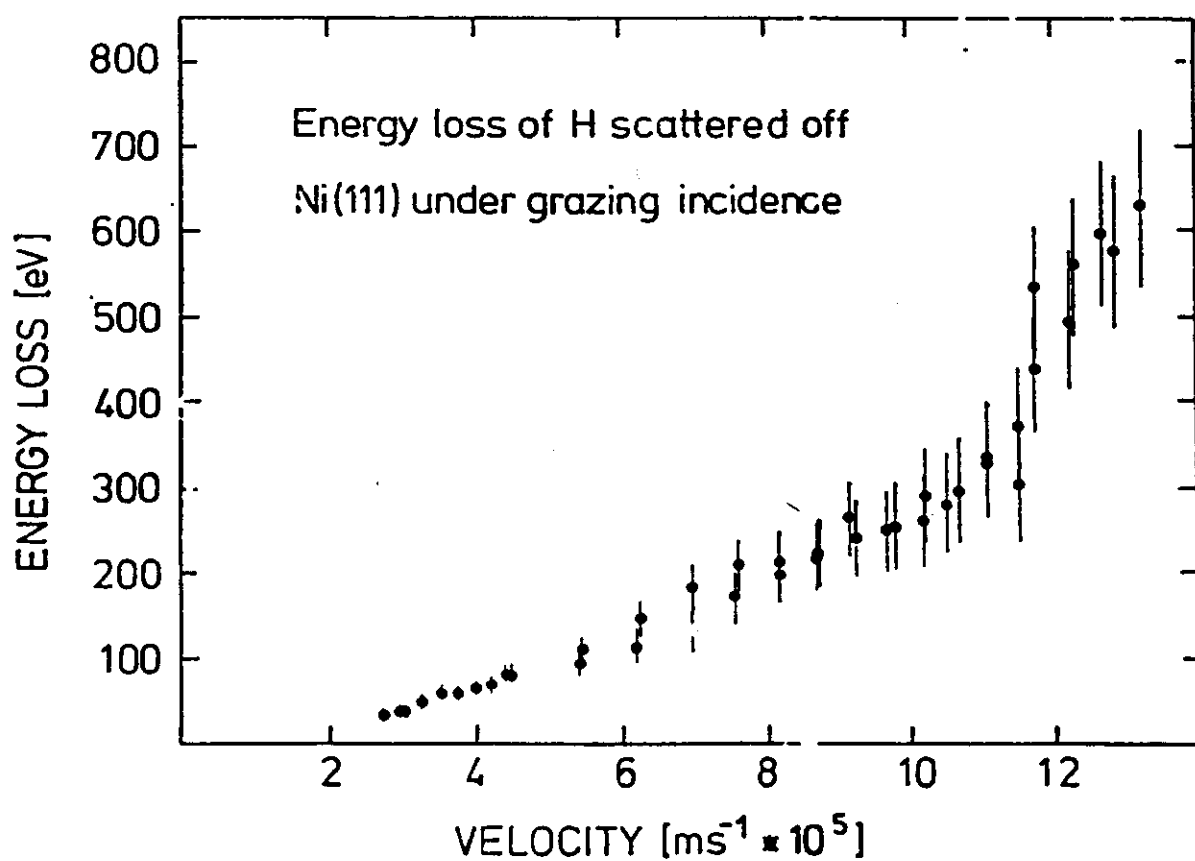
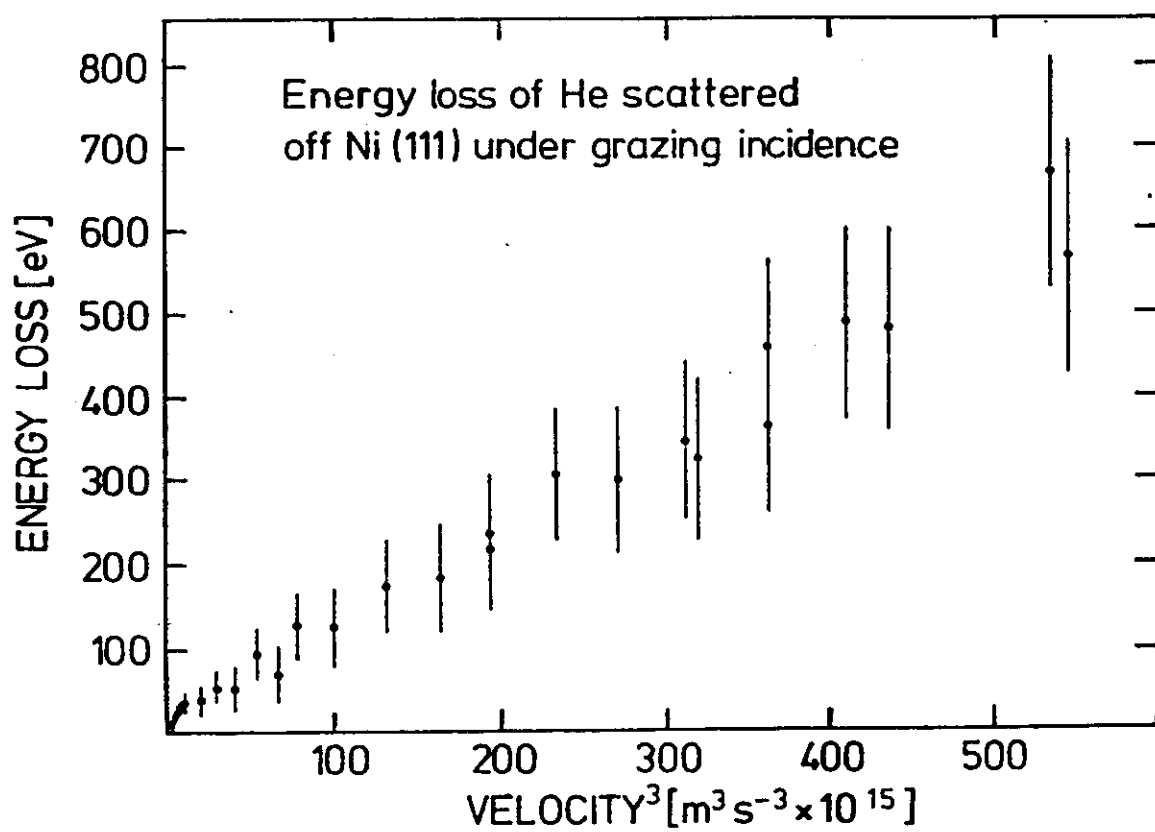
[110]

He $\rightarrow$ Ni(110)

360V, $\varphi = 5^\circ$, $\delta = 10^\circ$





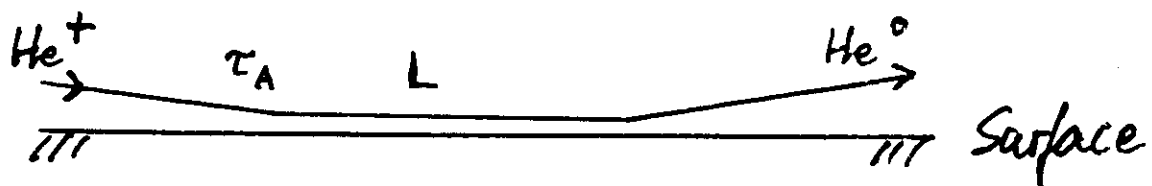


Energy Loss of H scattered from Ni. at Low Energies.

A. Nörmann, H. Frauke, U. Schmidt, C. Höfner
W. Heiland

Universität Osnabrück

- ① A. Nörmann et al P.R.L. 64 (1990) 1601
Charge exchange and energy dissipation



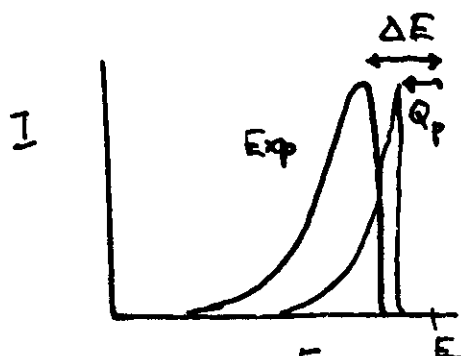
H. Berks et al N.I.M.B 44 (1989) 125 Channeling

R. Moreau et al Surf. Sci. 211/212 (1989) 271 τ_A
 $Q_p \sim v^3$ i.e. $Q_p = v \bar{f}_s L$ $\bar{f}_s \propto v$

- ② $H^+ \rightarrow \text{Surface} \rightarrow H^0, H^+, H^-$

$$Q_p \sim v^n \quad n \approx 2 \quad \text{or } \bar{f}_s \propto 1/v$$

" H^- "



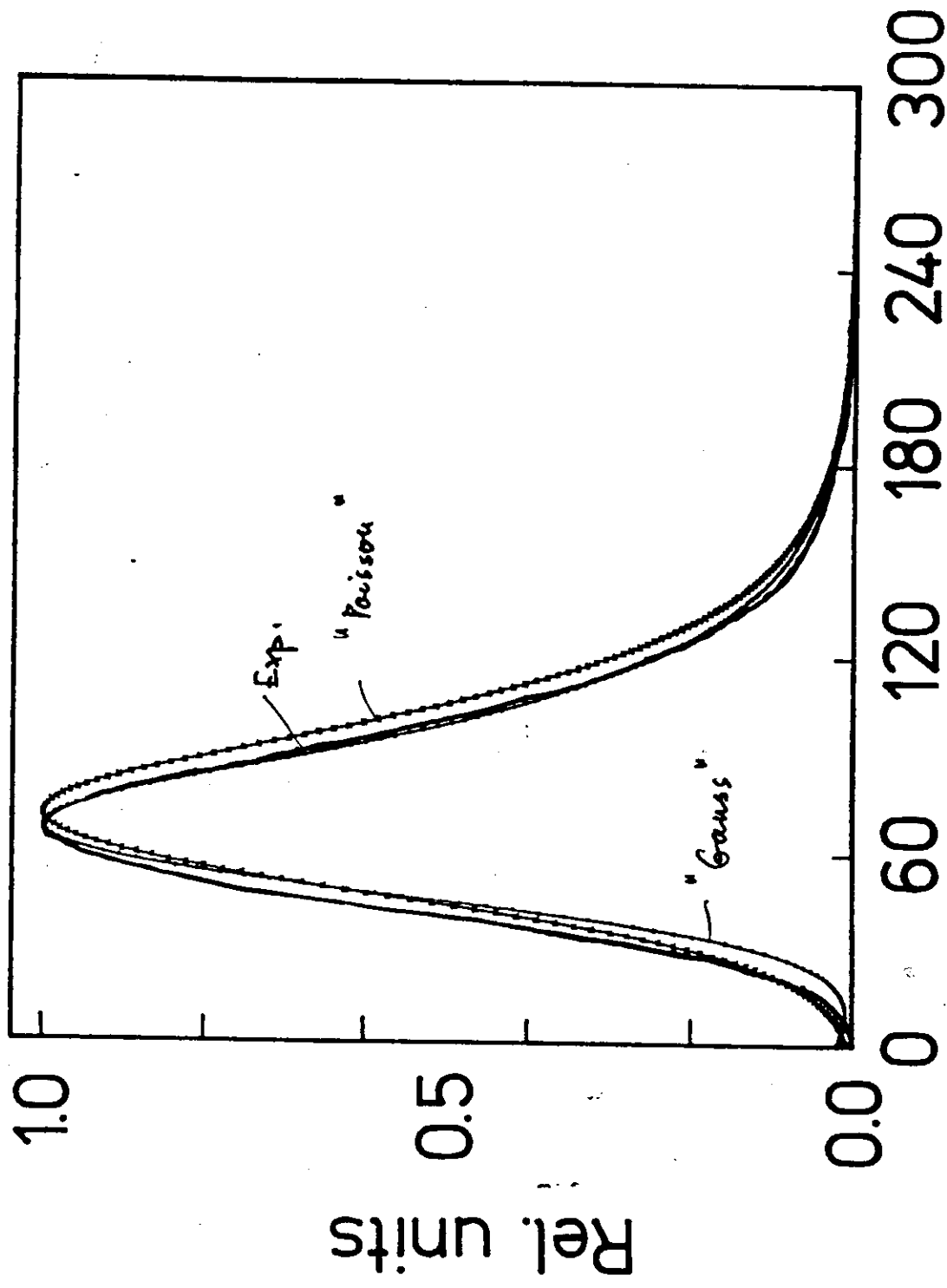
$\frac{dN}{dQ}$ without straggling

A. Nörreborn et al. Phys. Rev. Lett. 64 (1990) 1001

Energy distribution + straggling

(3 keV He $\rightarrow$ Ni)

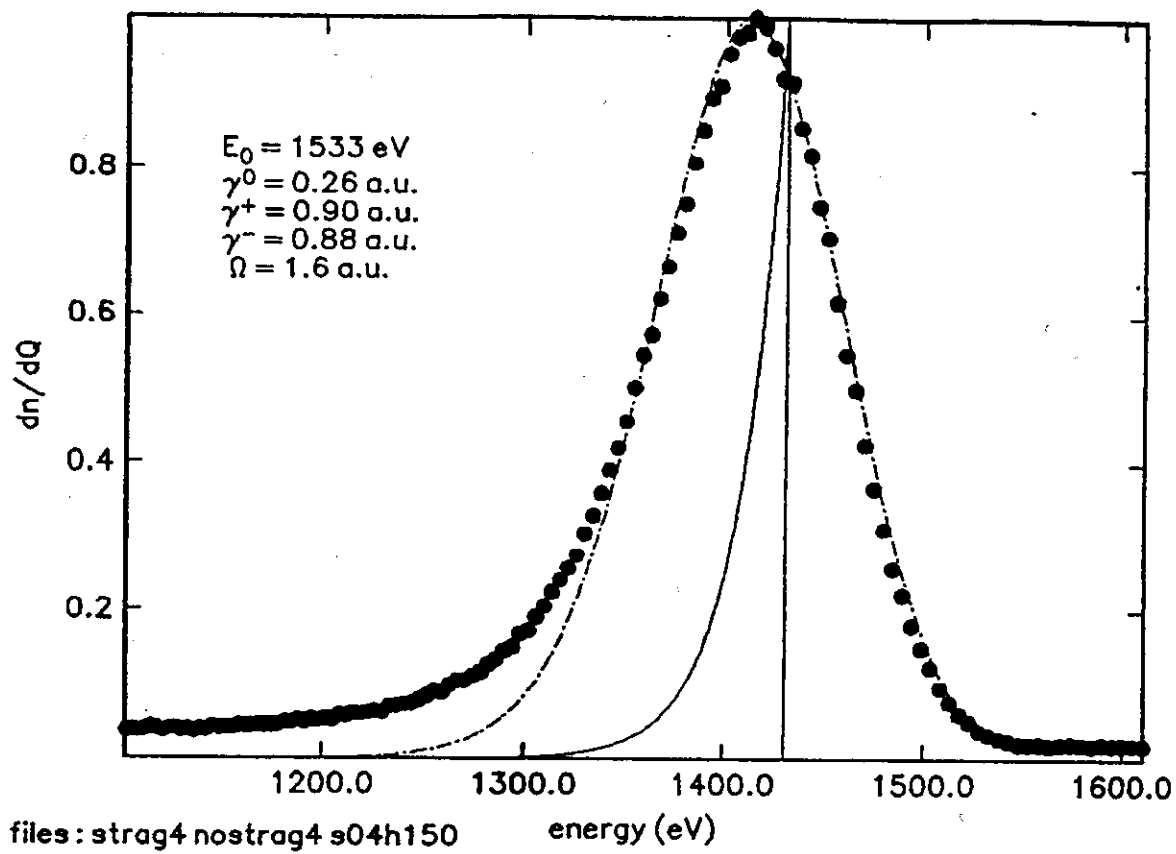
"Surface Scattering"



Number of collisions

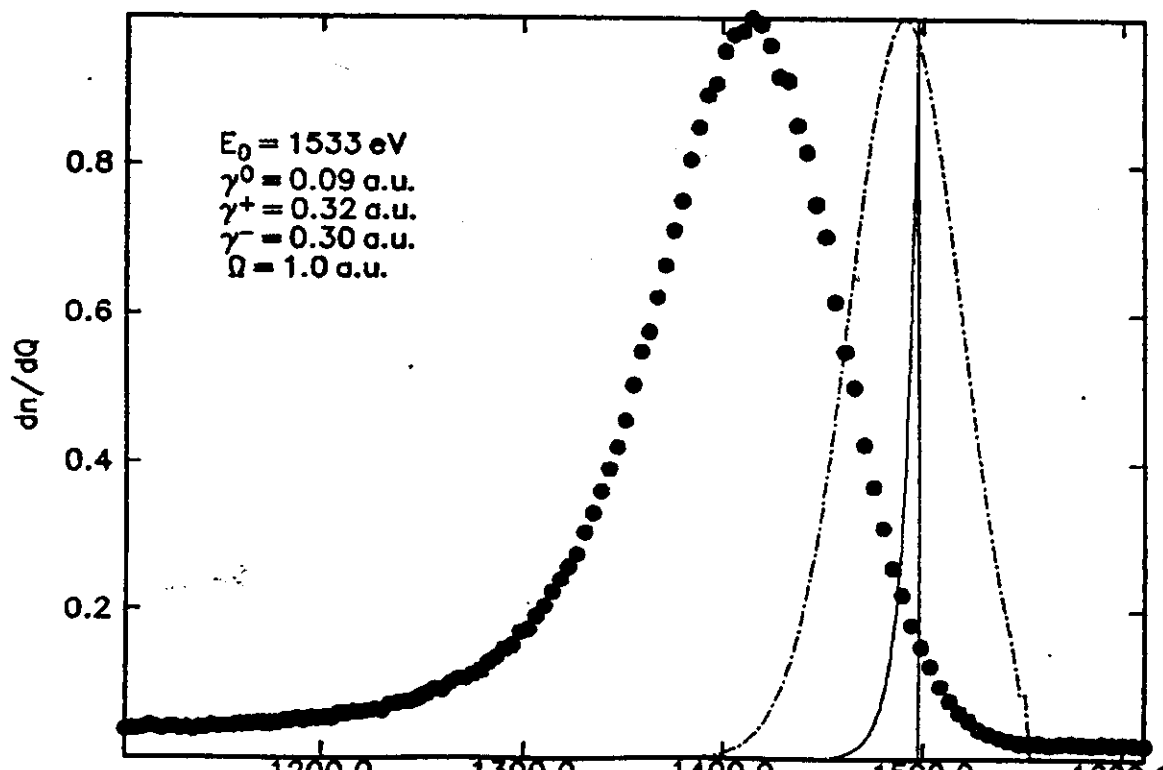
4.DIG

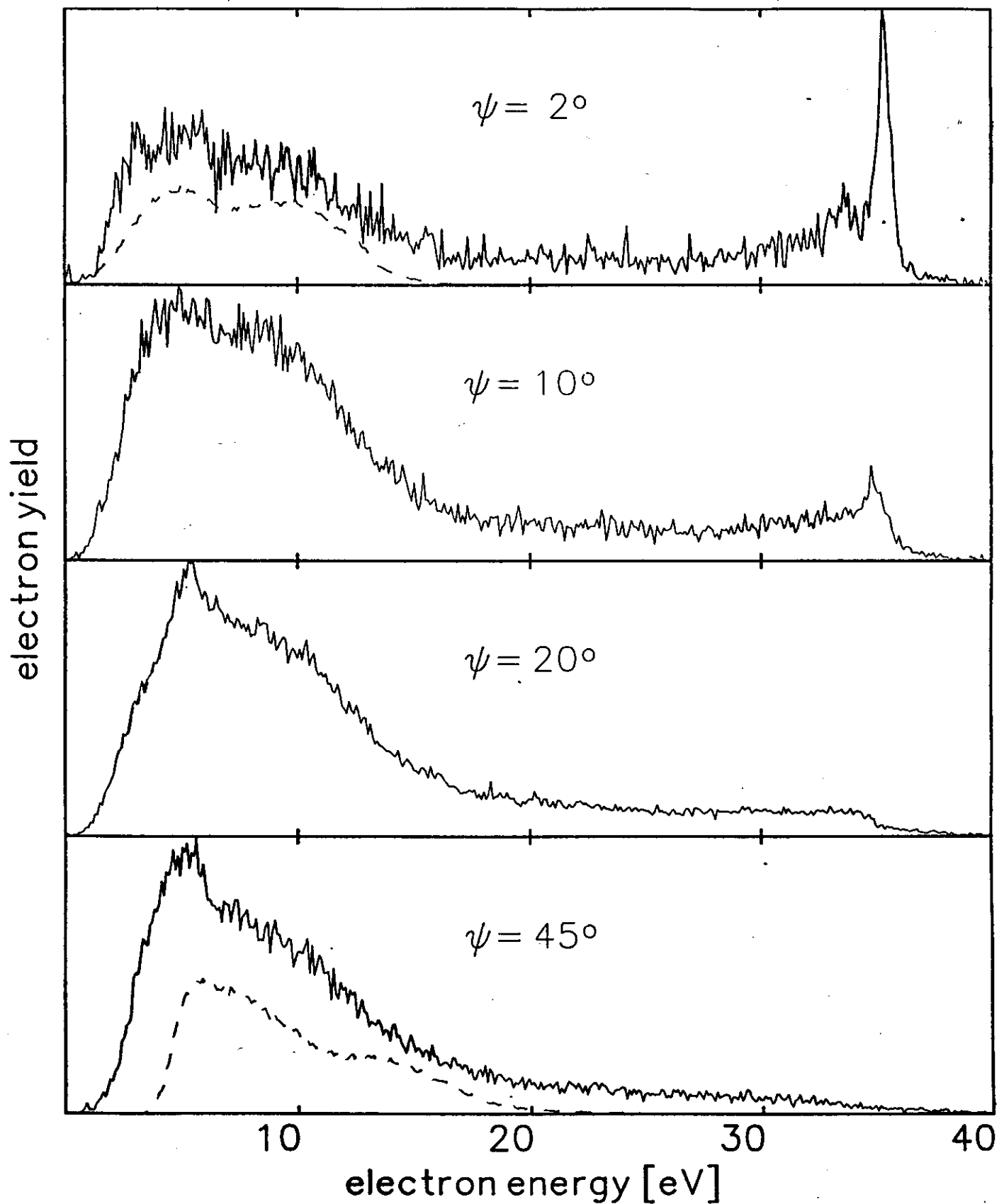
Nucl Instr. Meth 192



1.533 keV H^+ $\psi = 5^\circ$ $\theta = 10^\circ$ [random]

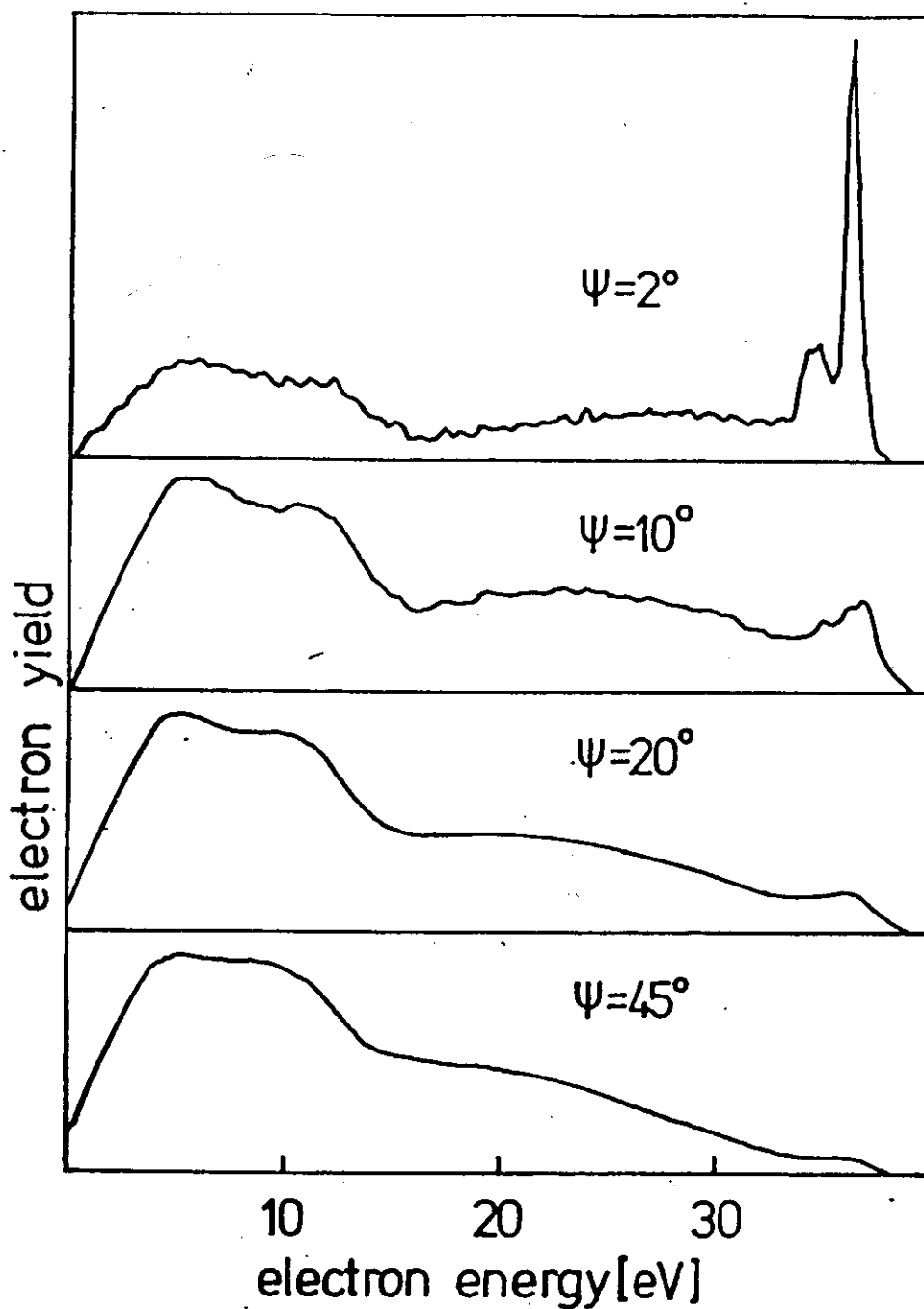
5.DIG





Electron spectra from $\text{He}^{++} \rightarrow \text{Pb}(111)$ (full lines) and $\text{He}^+ \rightarrow \text{Pb}(111)$ (broken lines) for different angles of incidence and $E_{\text{kin}} = 1 \text{ keV}$.

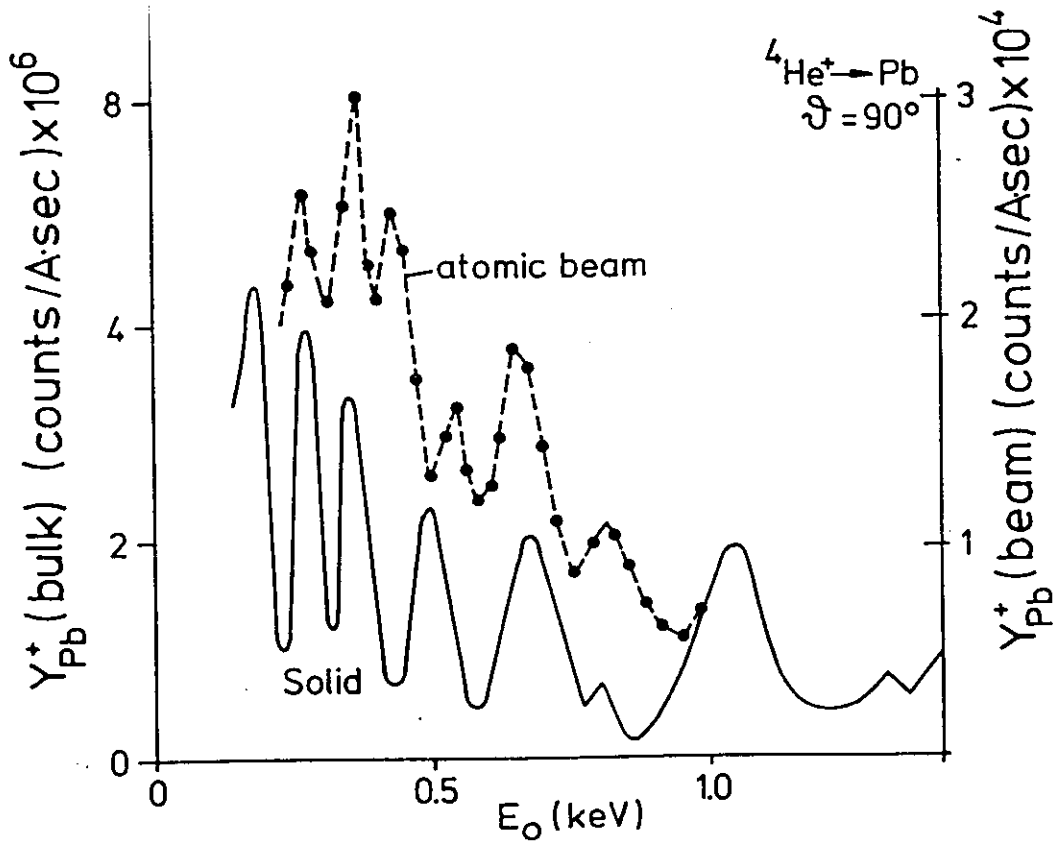
The abscissae of the He^+ curves are not to scale.



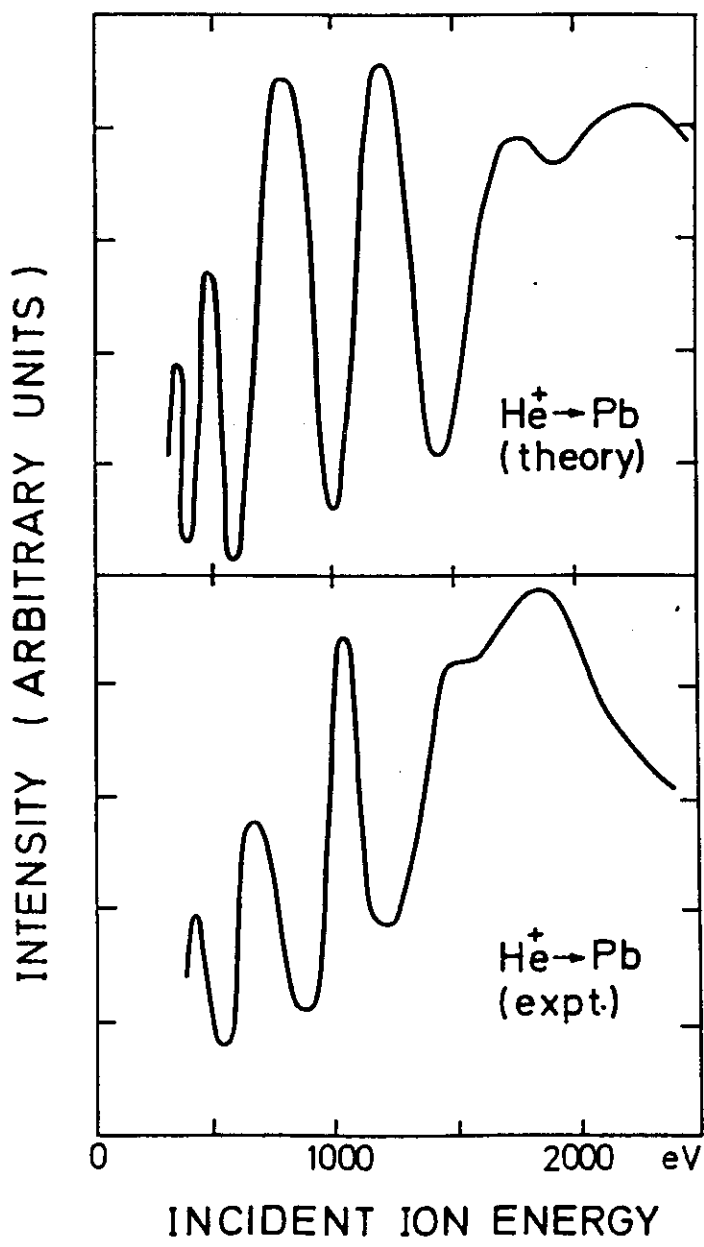
Calculated electron spectra for $\text{He}^{++} \rightarrow \text{Pb}(111)$, $E_{\text{kin}} = 1\text{keV}$, impact angle as parameter.

The following table lists the relevant spectral contributions together with the maximum values of the respective transition rates:

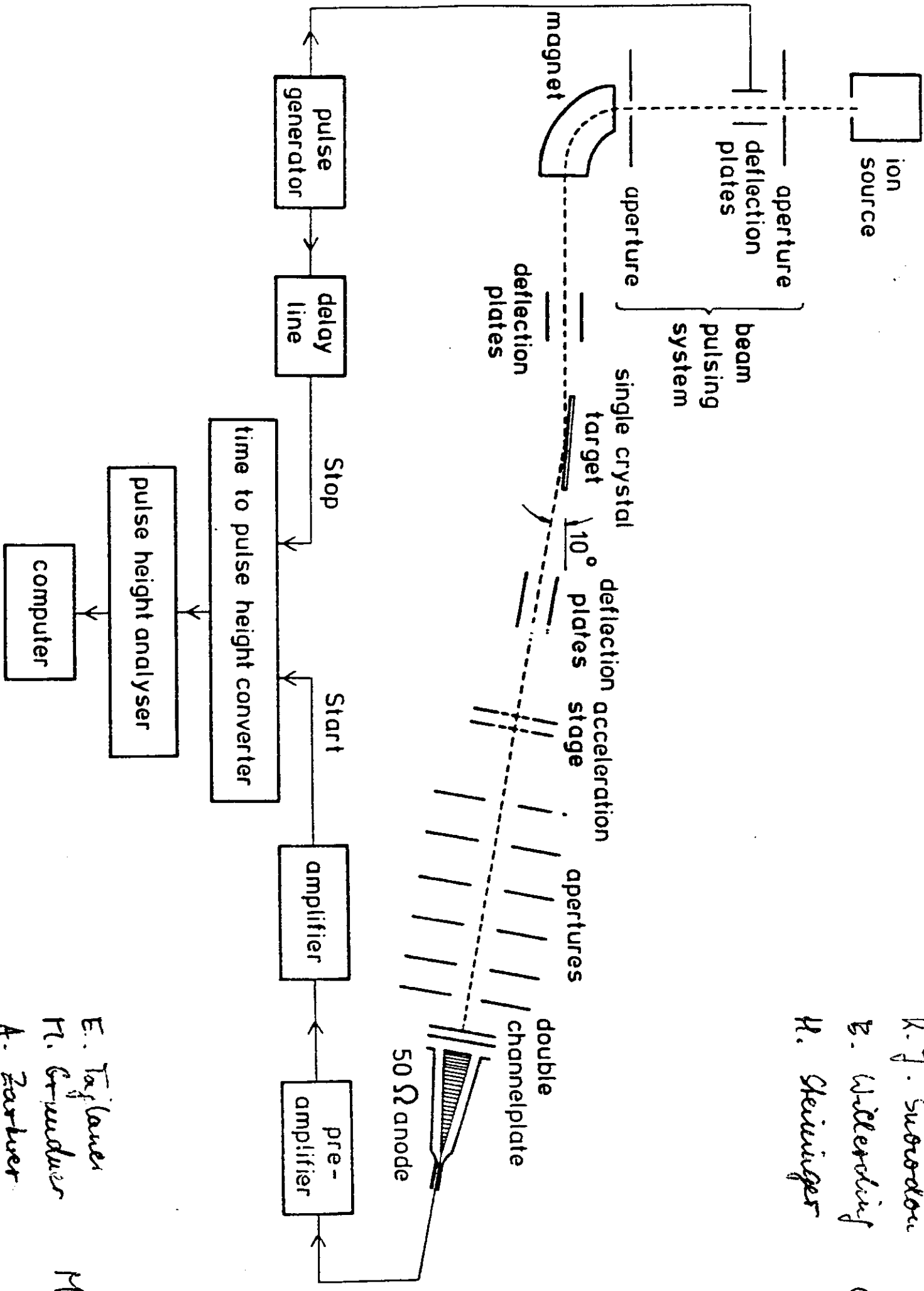
AC(1,0)	$3.0 \times 10^{15}\text{s}^{-1}$
AC(2,0)	$1.7 \times 10^{15}\text{s}^{-1}$
RC(2,1)	$9.6 \times 10^{14}\text{s}^{-1}$
RC(2,0)	$4.2 \times 10^{14}\text{s}^{-1}$
AU(2,2) - $\text{He}^{**}(2s^2)^1\text{S}$	$1.7 \times 10^{14}\text{s}^{-1}$ §
AU(2,2) - $\text{He}^{**}(2p^2)^1\text{D}$	$8.3 \times 10^{13}\text{s}^{-1}$ §



Taylor
 Heiland
 PRL
 1978

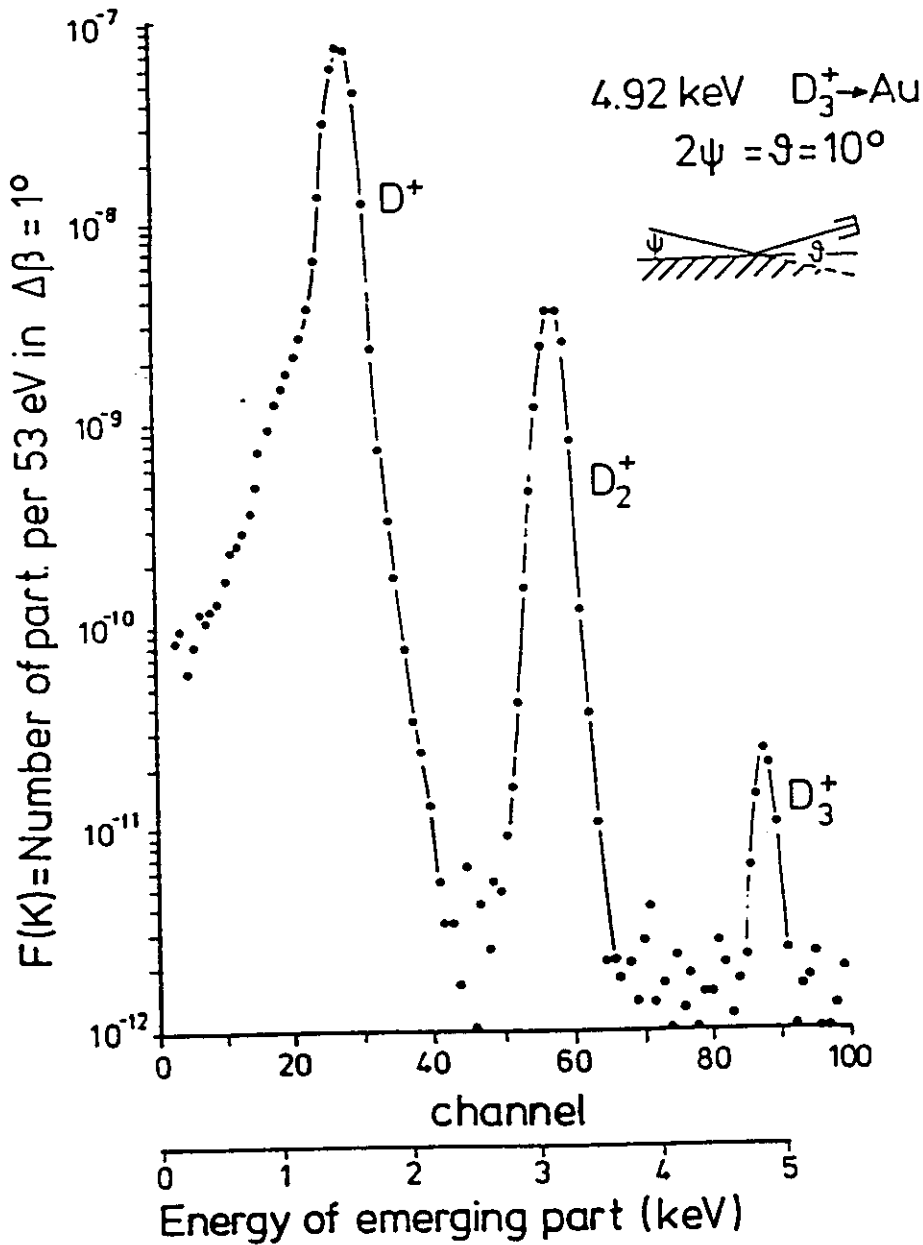


J. Tully
 PRB
 1977



K. J. Suerdon
 E. Willebrandt
 H. Steiniger
 CS

E. Tagliavini
 H. Grunwaldt
 A. Zarkner
 M

**Fig. 29:**

Energy spectra of D_3^+ and its dissociation products D_2^+ and D^+ incident at $E_0 = 4.92 \text{ KeV}$ on Au , $\psi = 5^\circ$, $\theta = 10^\circ$. $\Delta\beta$ is the angle of acceptance of the detector (Eckstein et al.¹⁵⁹)

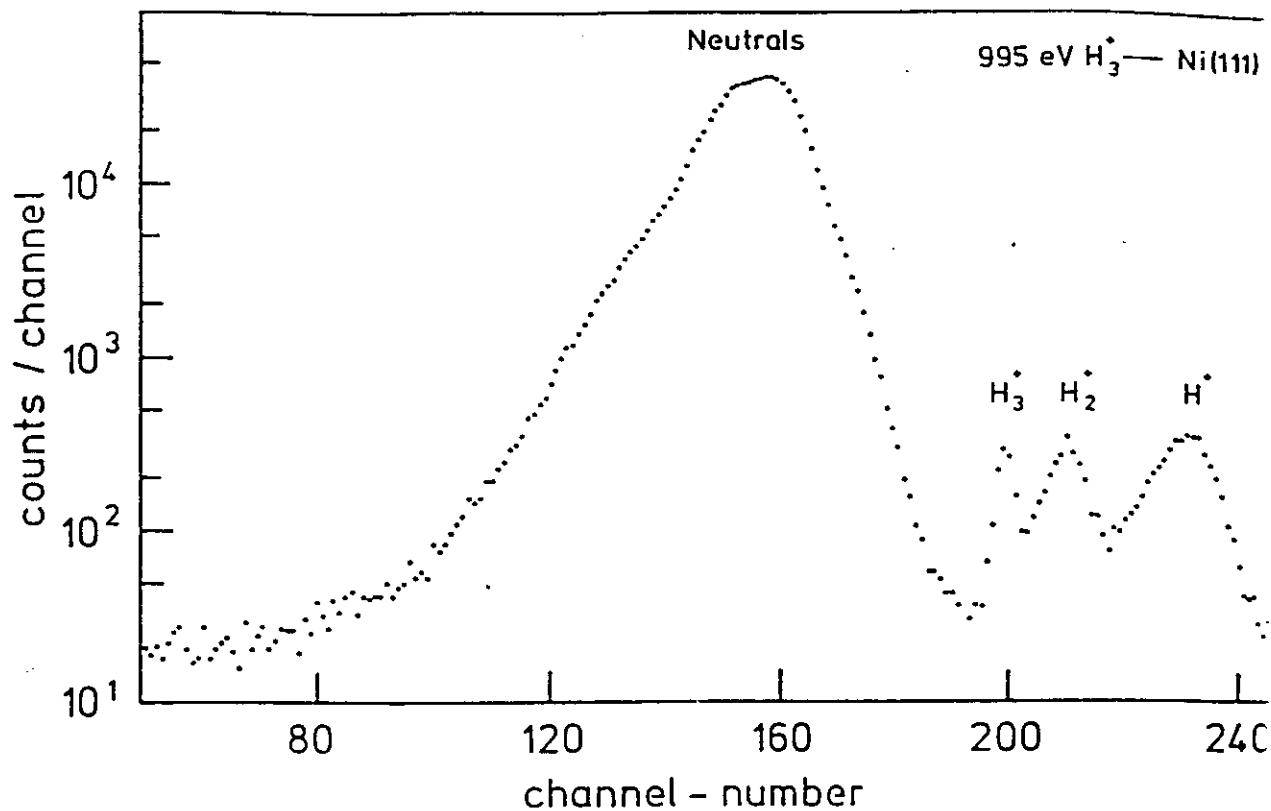


Fig. 30:

Time of flight spectra of H_3^+ and of its ionic and neutral dissociation products, $E_0 = 495 \text{ eV}$, $\psi = 5^\circ$, $\theta = 10^\circ$ (Willerding et al.¹⁶⁰)

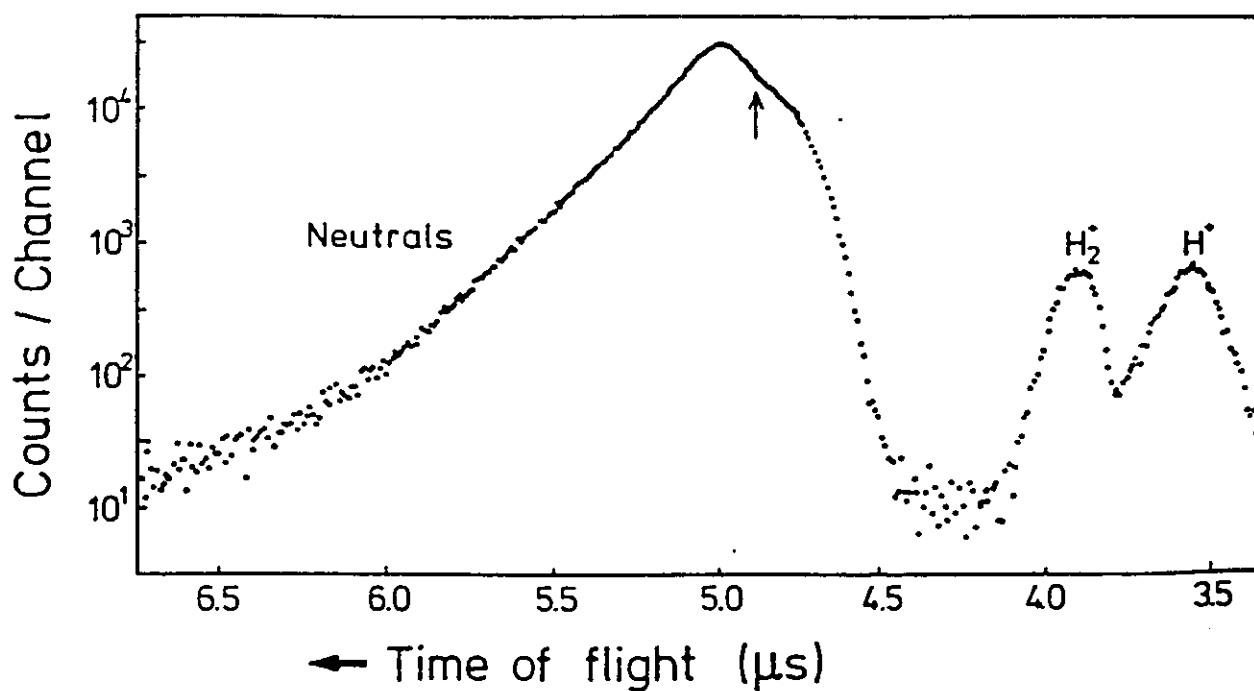
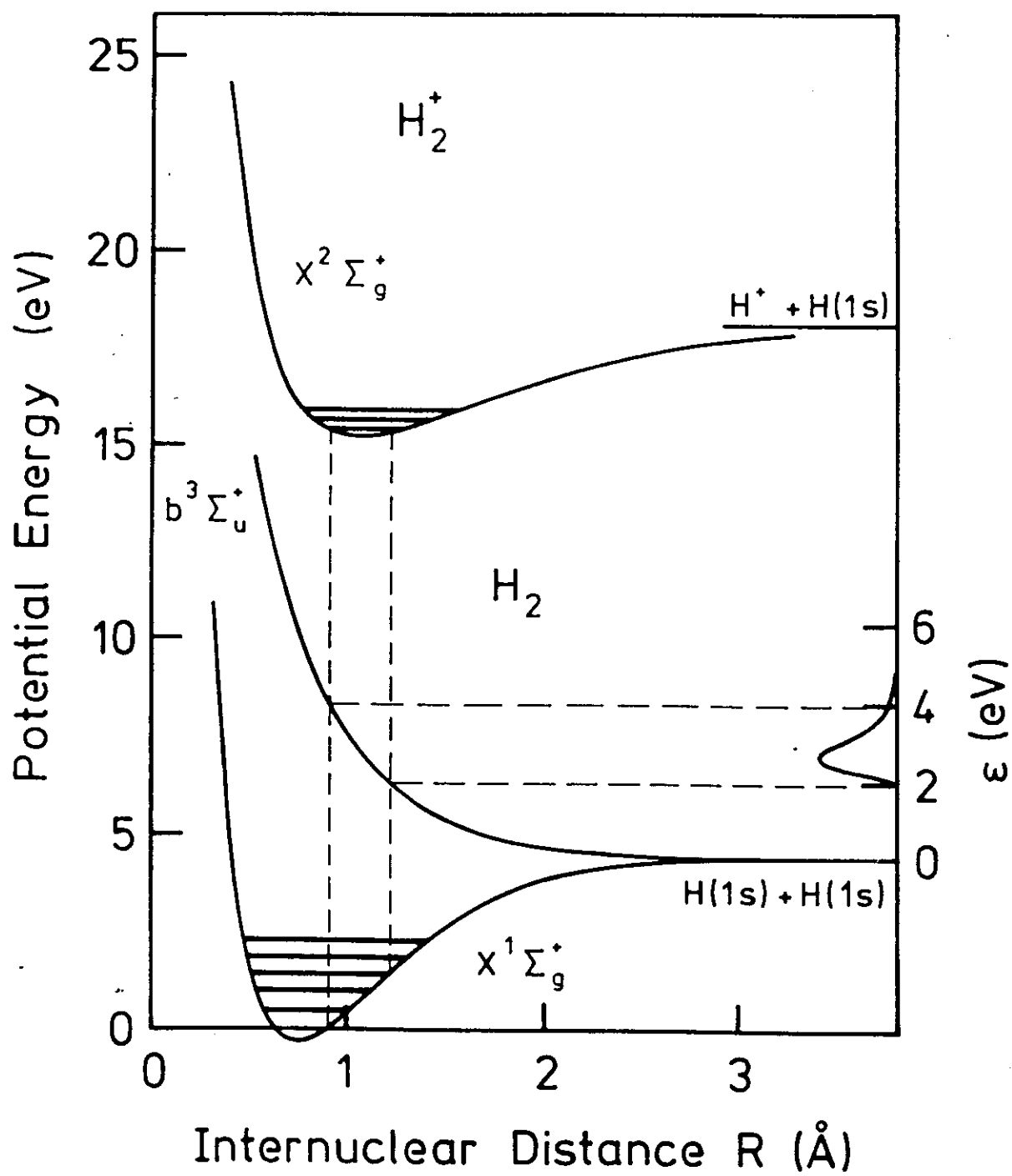
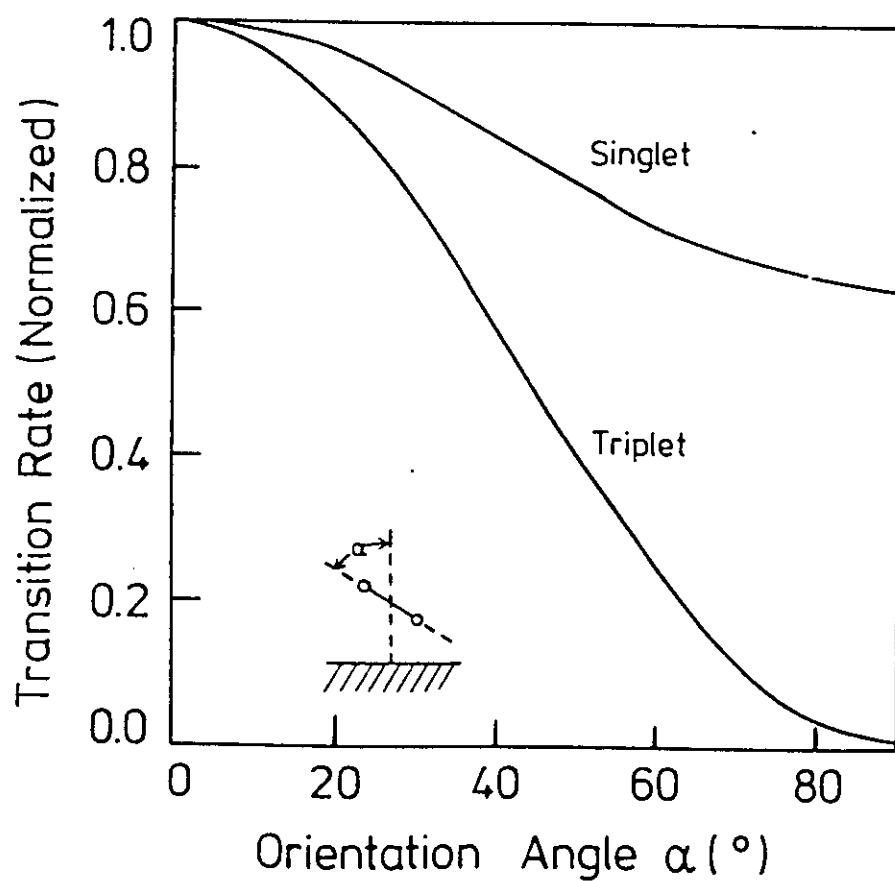
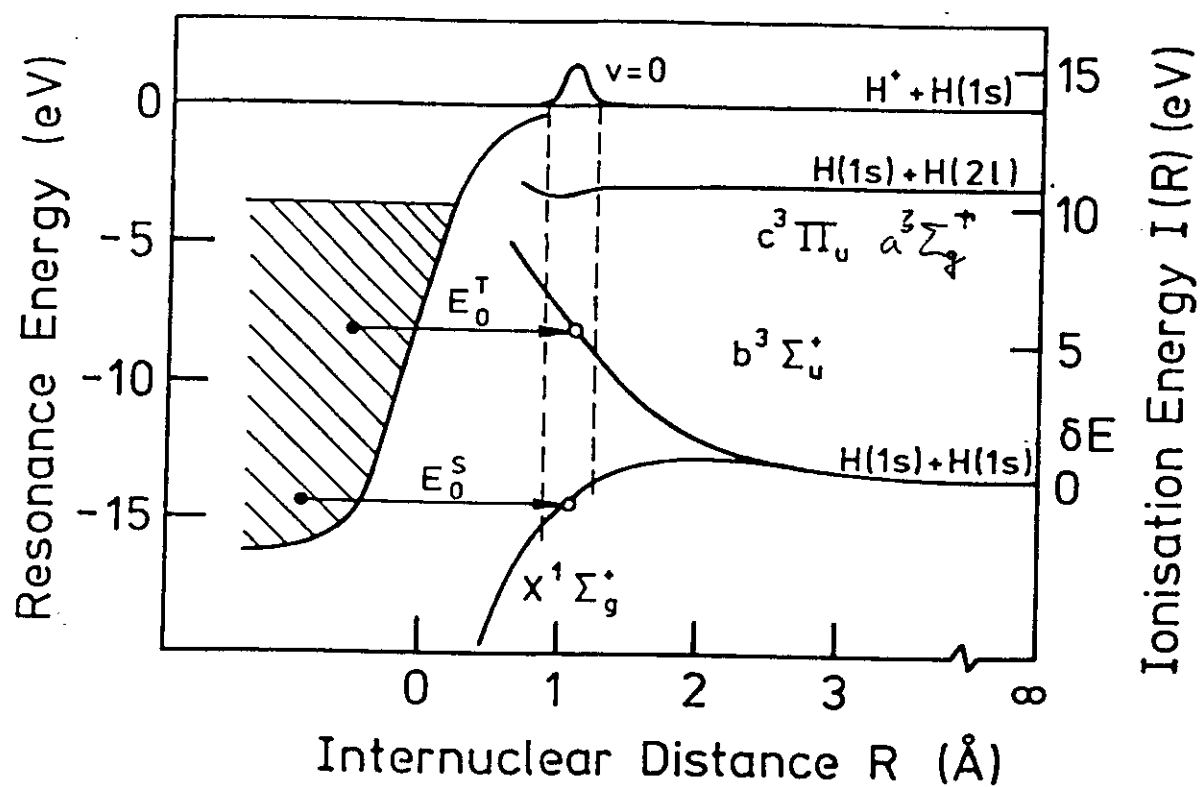


Fig. 31:

Time of flight spectra of H_2^+ and of its dissociation products from Al(111) for $E_0 = 200 \text{ eV}$ (Imke¹⁶¹)

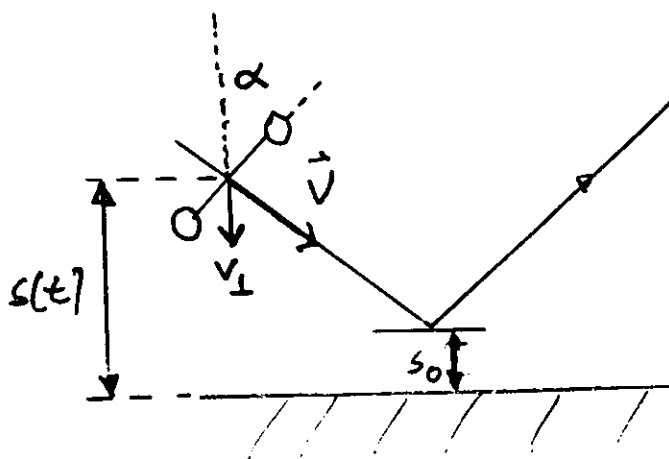




Transition probabilities and:
Symmetry considerations
(G. H. Dunn)

Initial state	orientation	$N_2, H_2, N+N, Z_g^+$	final state $H+H, O+O, Z_h^+$	$O+O, \Pi_g$
H_2^+, N_2^+, Z_g^+	$\parallel$	Large	Small	
	$\perp$	Large	Large	
O_2^+, Π_g	$\parallel$	Small	Large	Large
	$\perp$	Small	Small	Large

U. Funke et al
Al ('jellium') and H_2^+ resonant transitions

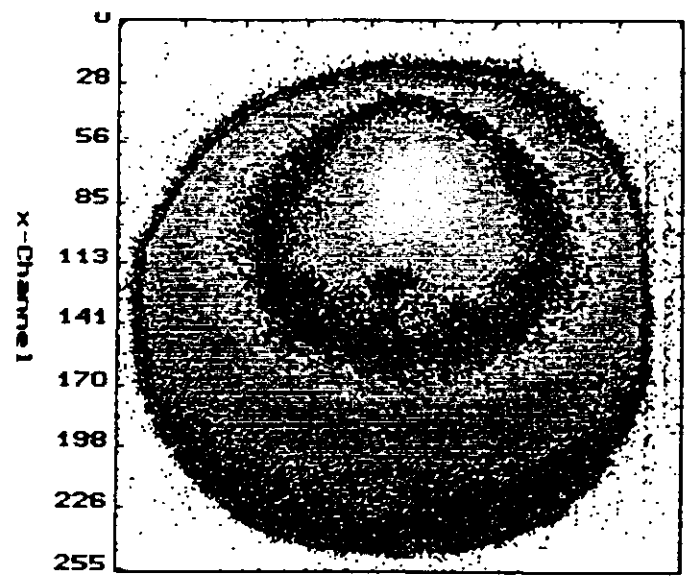


Varga, Schubert, Funke : O_2^+ vs N_2^+

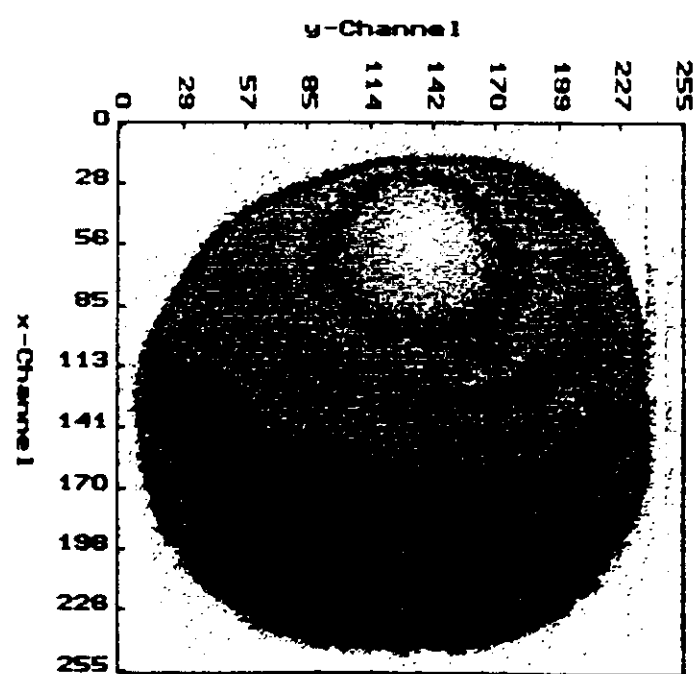
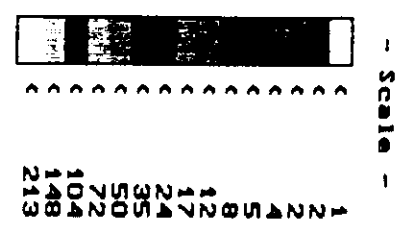
W. Tappe '91
Europhys. Lett

$E_0 = 3 \text{ keV}$; H_2^+
 $\gamma = 5^\circ$

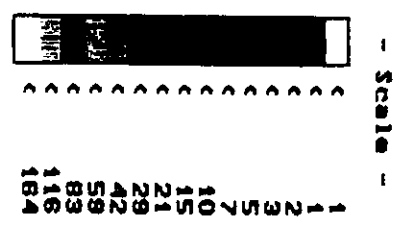
Ni(110)
<random>



15089016



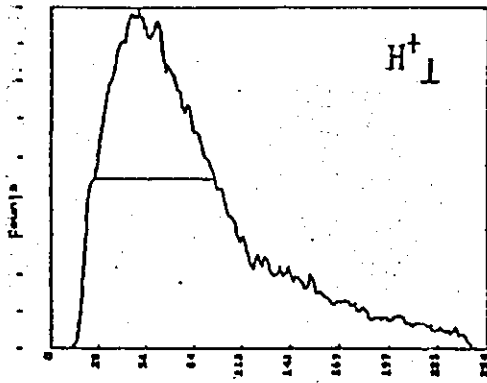
18089002



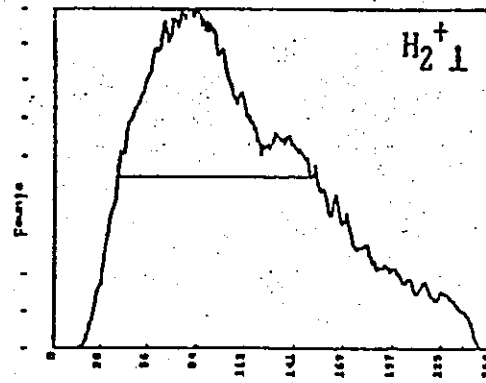
$E_0 = 1.5 \text{ keV}$; H^+
 $\gamma = 5^\circ$
Ni(110)
<random>

VII

Schnitte durch die Streuverteilungen (jeweils durch das Maximum).
Die Schnitte sind normiert.

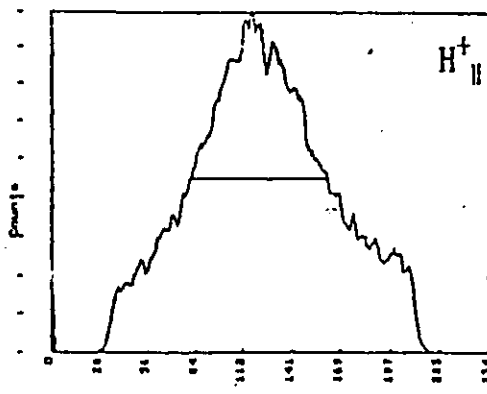


FWHM: 71 Kanäle

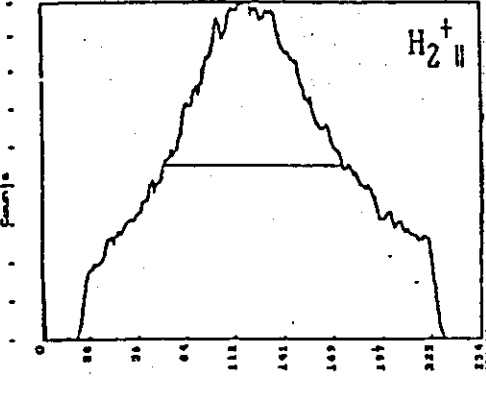


FWHM: 112 Kanäle

$\Delta k = 41$ Kanäle



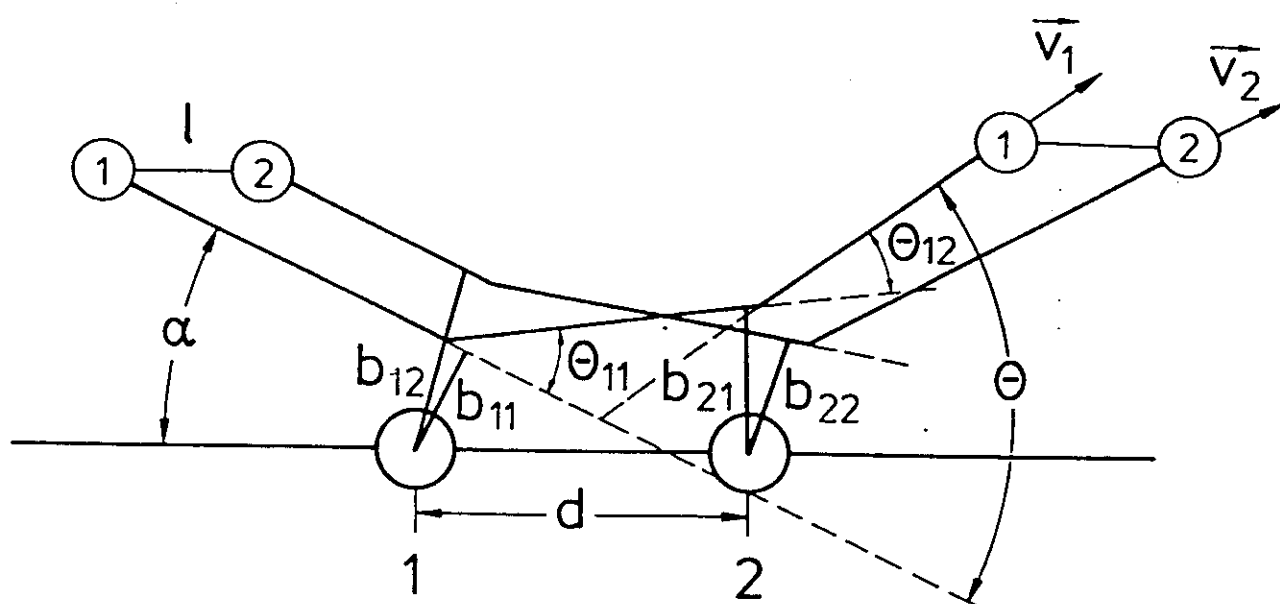
FWHM: 81 Kanäle

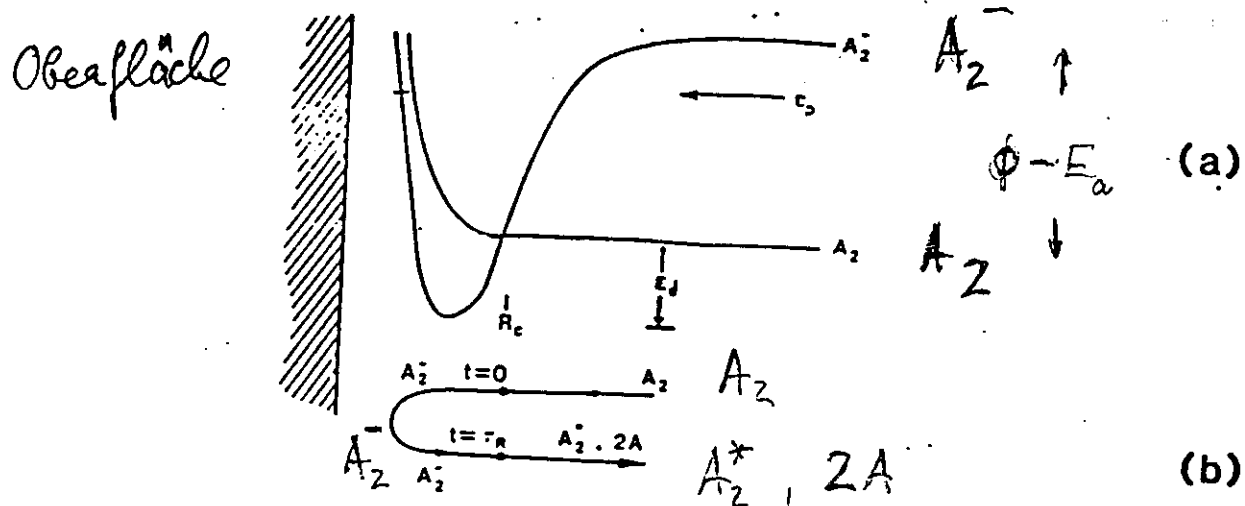


FWHM: 103 Kanäle

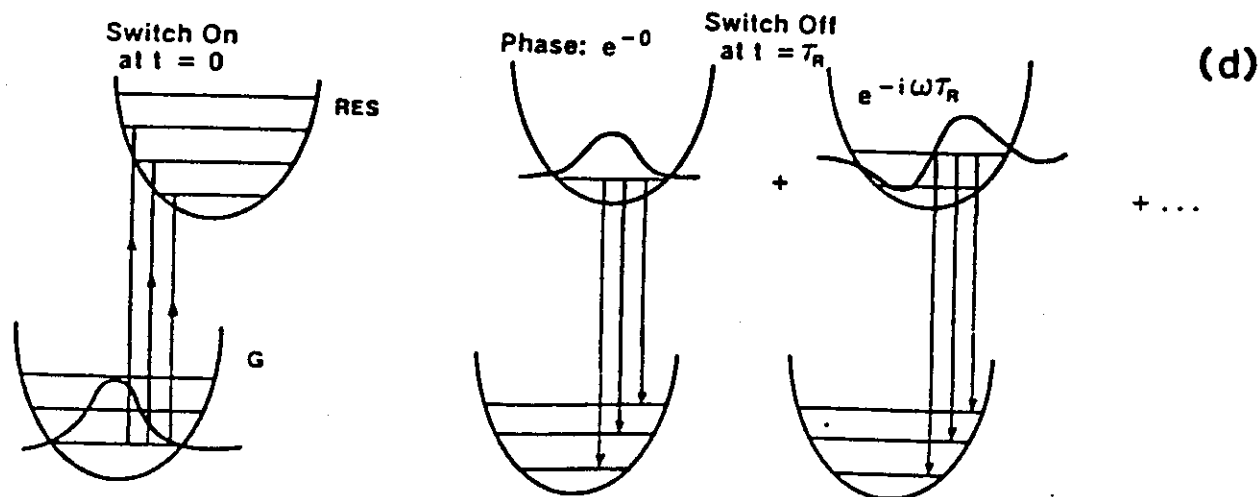
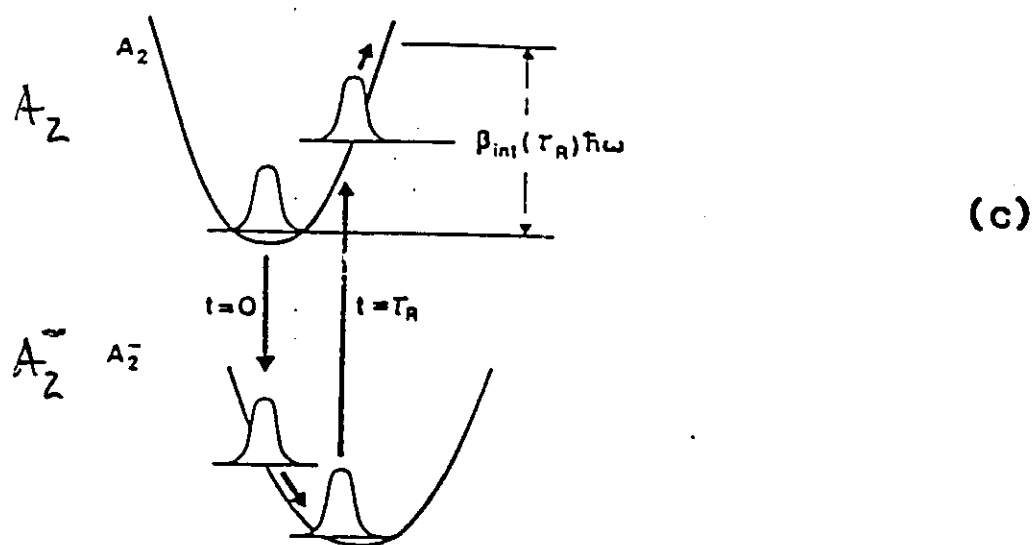
$\Delta k = 22$ Kanäle

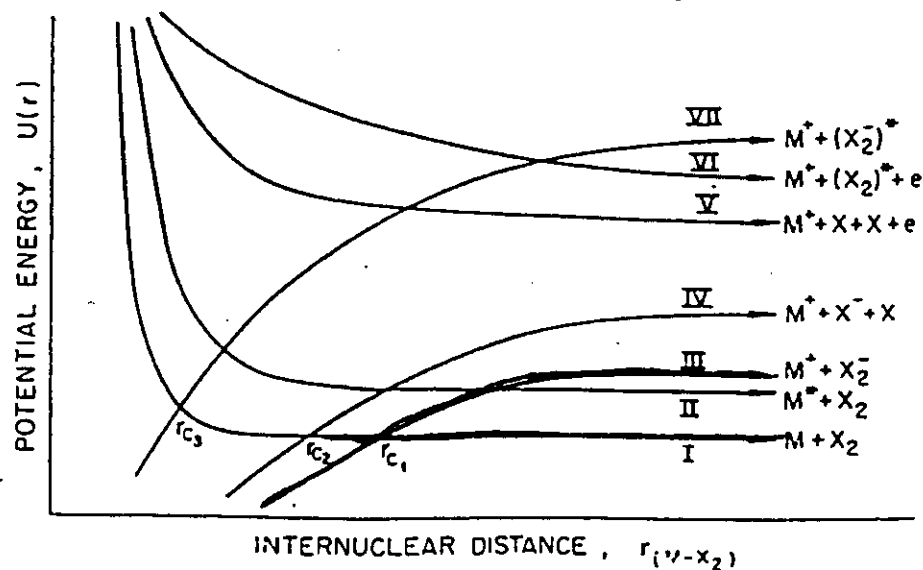
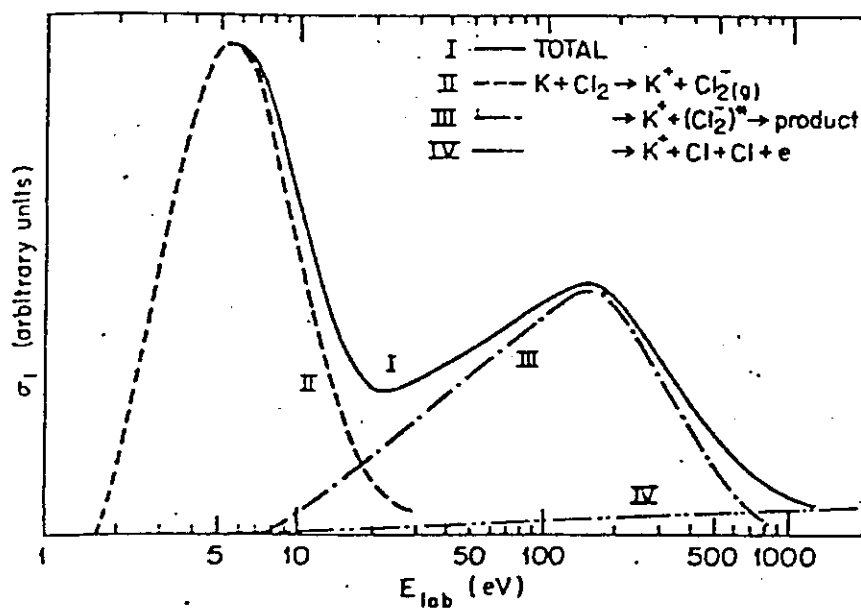
- Ergebnis:
- Aufweitung des molekularen Strahls gegenüber dem atomaren Strahl
 - senkrecht zur Oberfläche ($\perp$) ist diese Aufweitung ($\Delta k = 41$ Kanäle) größer als parallel ($\parallel$) zur Oberfläche ($\Delta k = 22$ Kanäle)





Vibrational excitation in Molecule - Surface Collisions





"harpoon model"

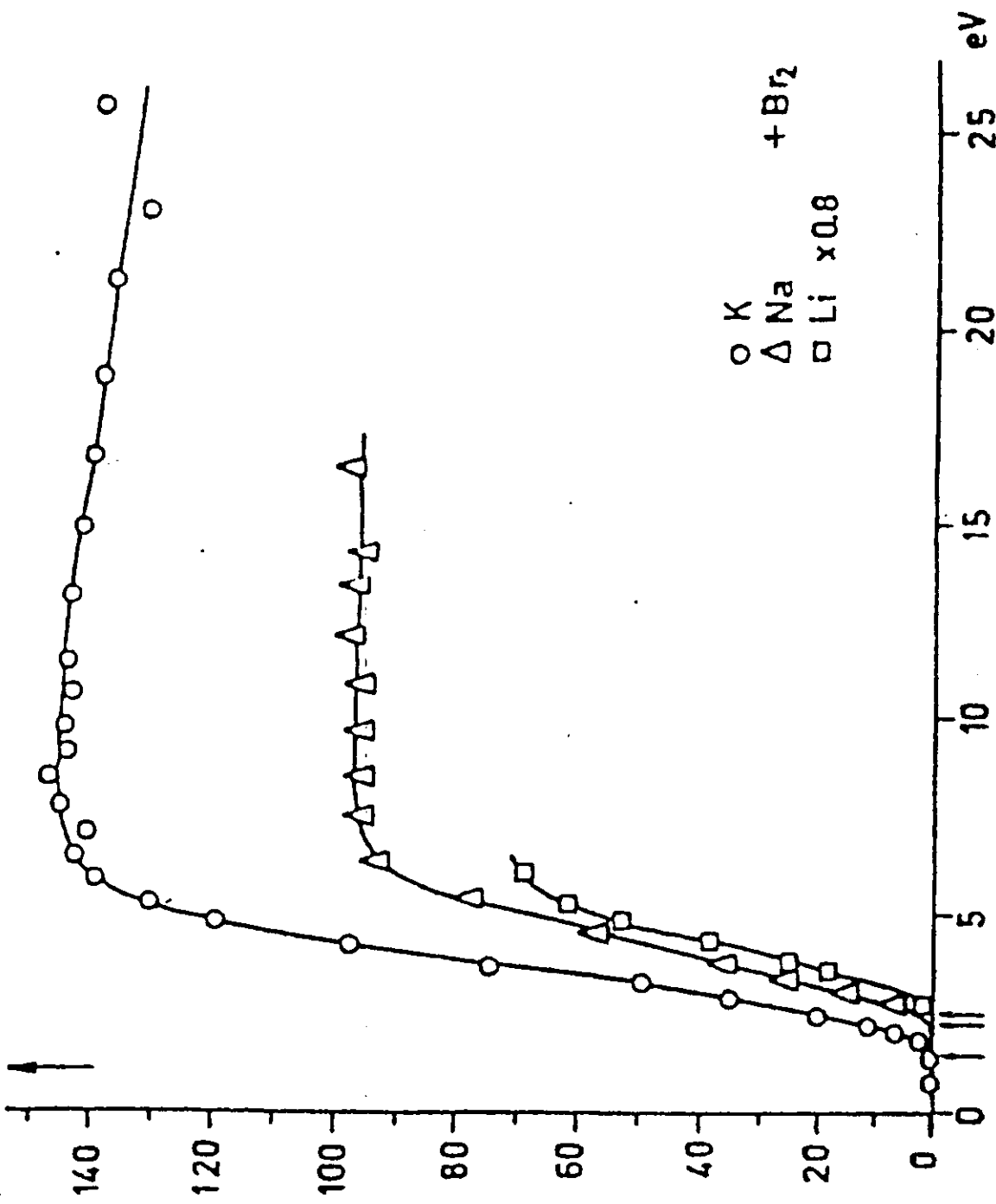
"electron jump mechanism"

M. Pofanyi

D.R. Herschbach

A. P. M. Baedé, A. H. C. Houtman, A. E. de Vries, and J. Los

$\beta^{-1} Q$ (arbitr. units)



○ K
△ Na
□ Li x0.8

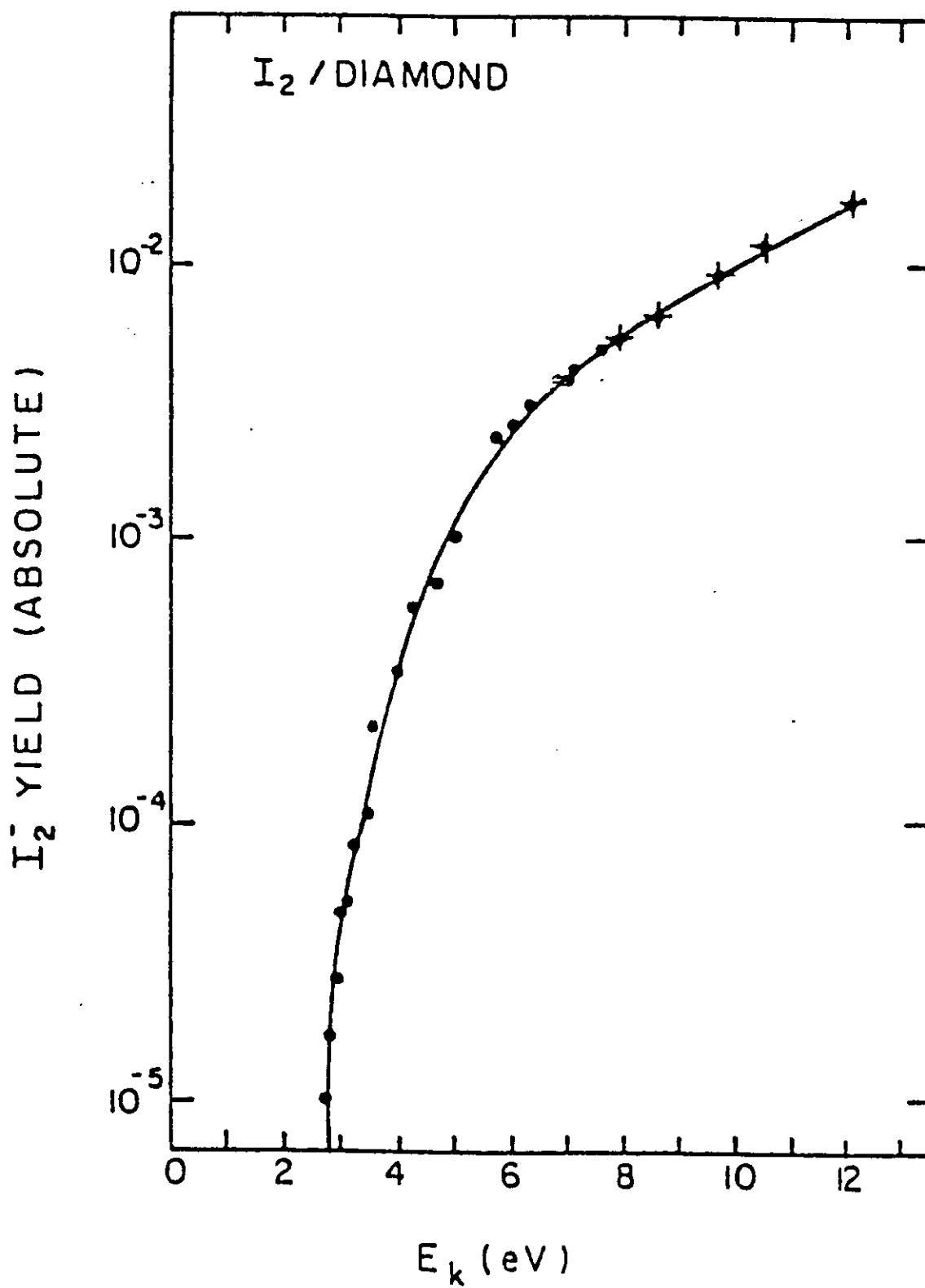
+ Br₂

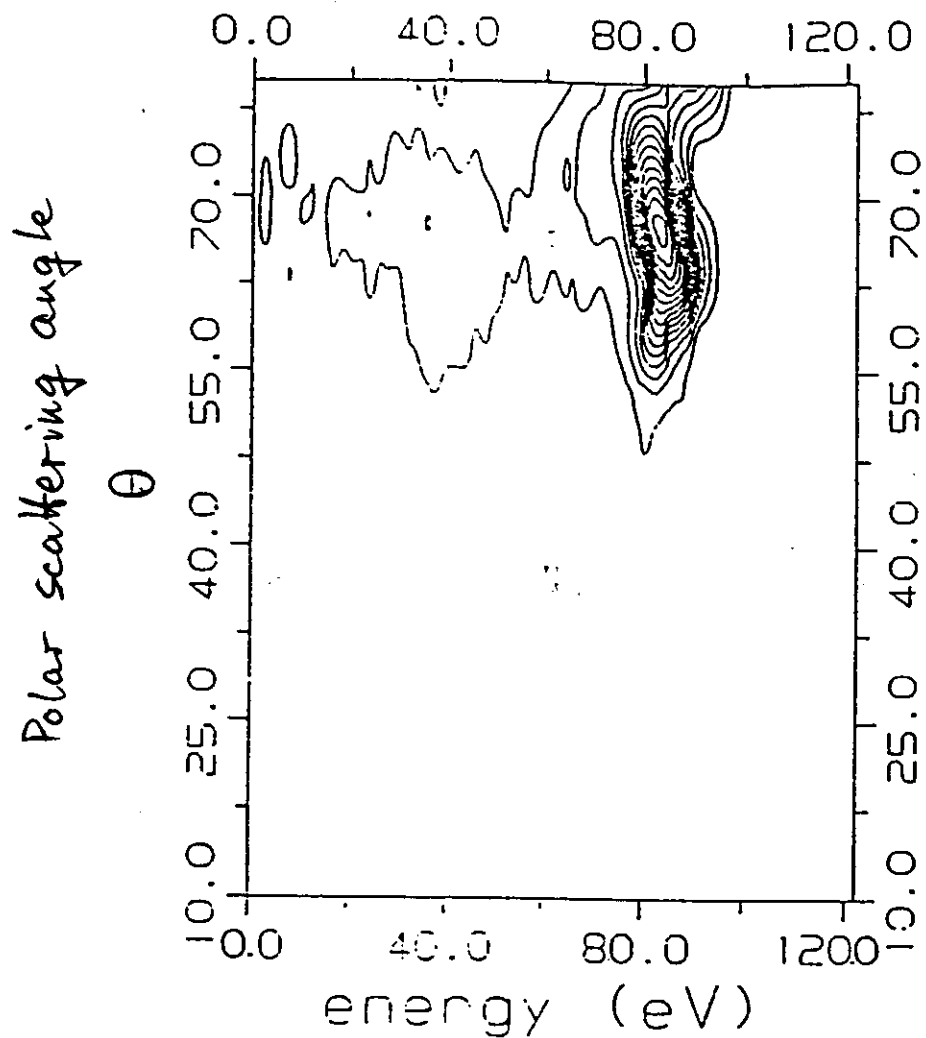
→ Energy (eV)

$$E_{thr} = I(M) - E(X_2)$$

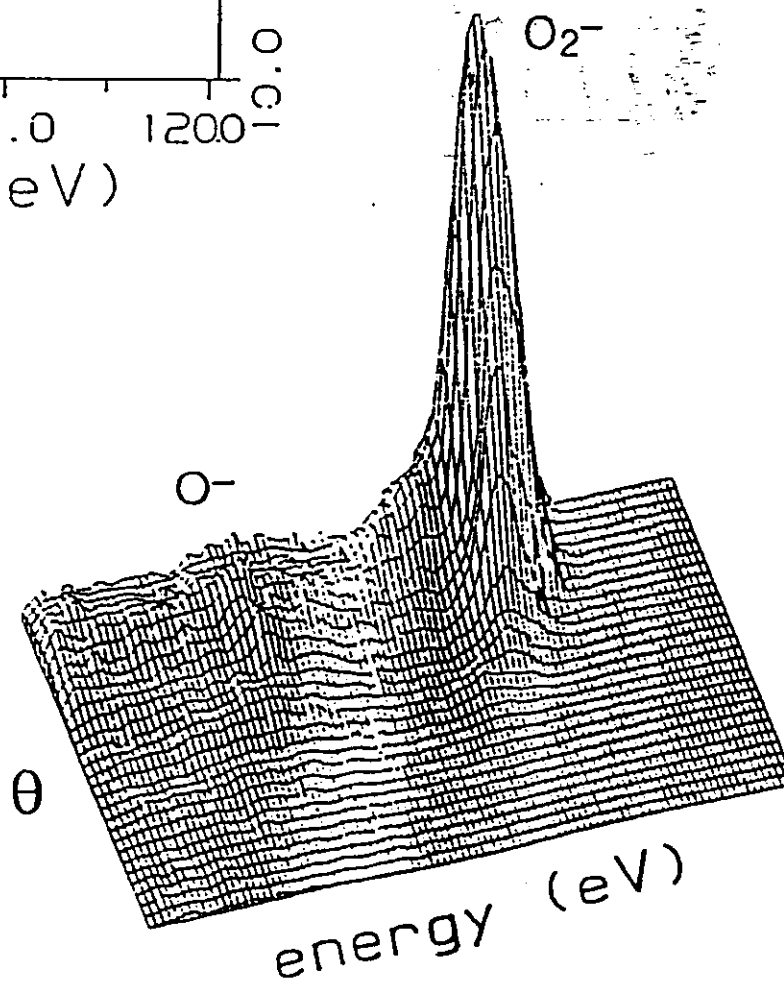
$$= \frac{e^2}{4\pi\epsilon_0 r_c}$$

" pseudocrossing
of the homopolar
and ionic potential
energy surface "

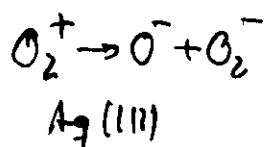


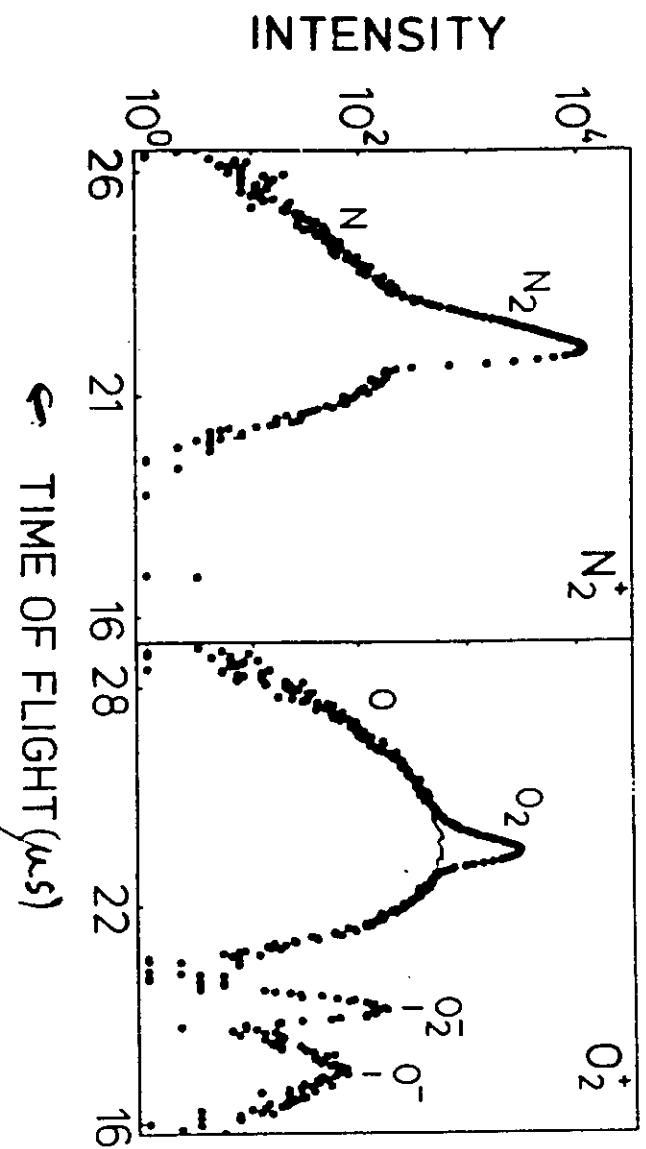
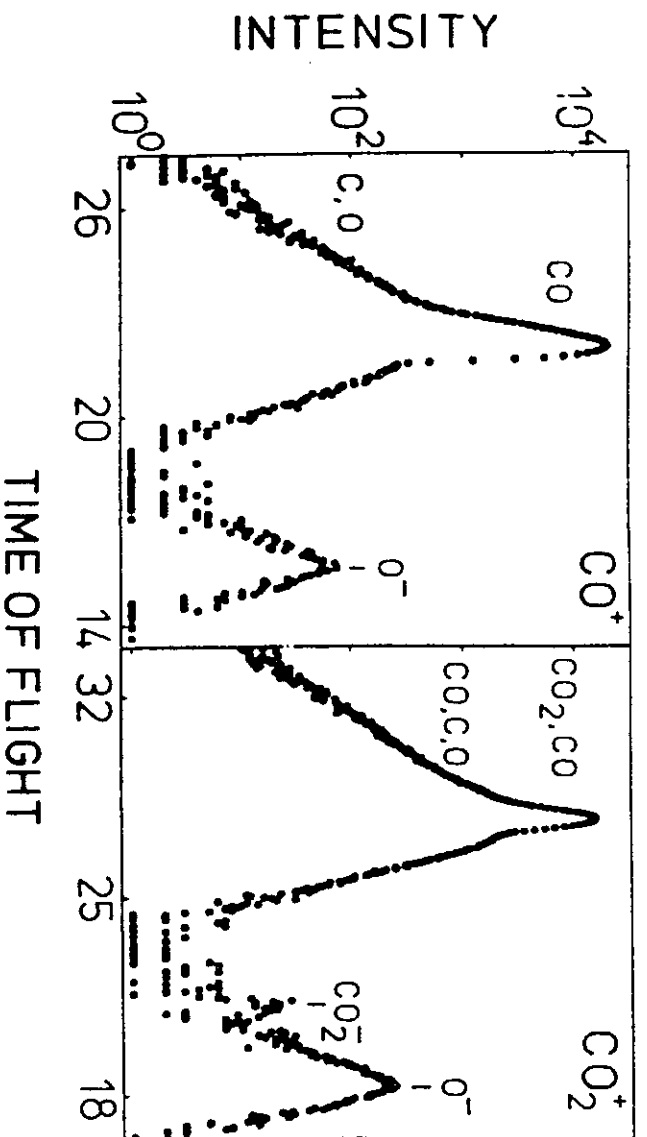


100 eV $O_2 \rightarrow Ag(111)$
 $\psi = 20^\circ$



van Hoochling
 T.C.M. Horn
 A.W. Kleyen
 P.R.L. 57
 (1986) 3035





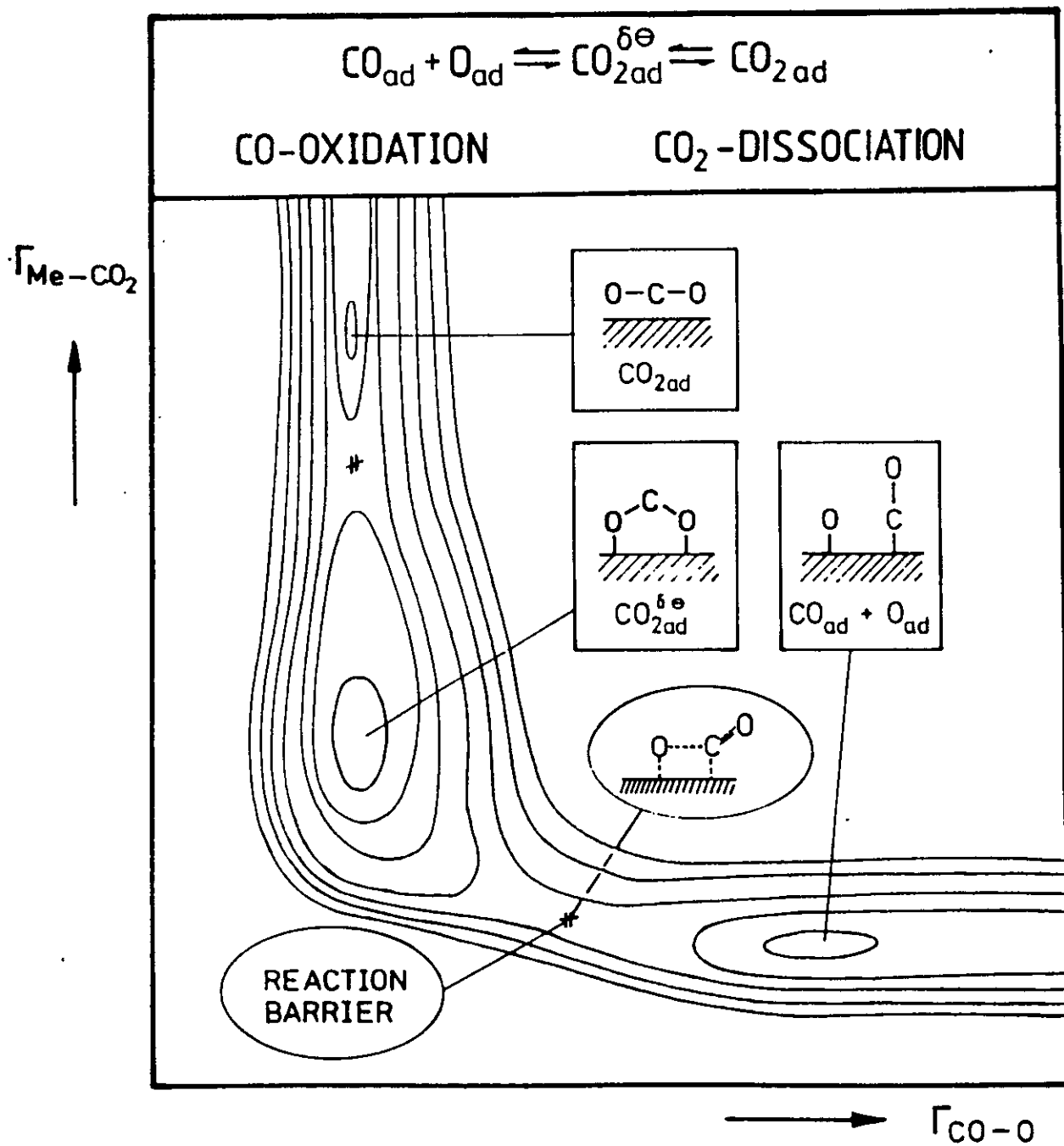
A. Kleyn
P. Reijne
S. Schuster
U. Enke
H. Rodhe

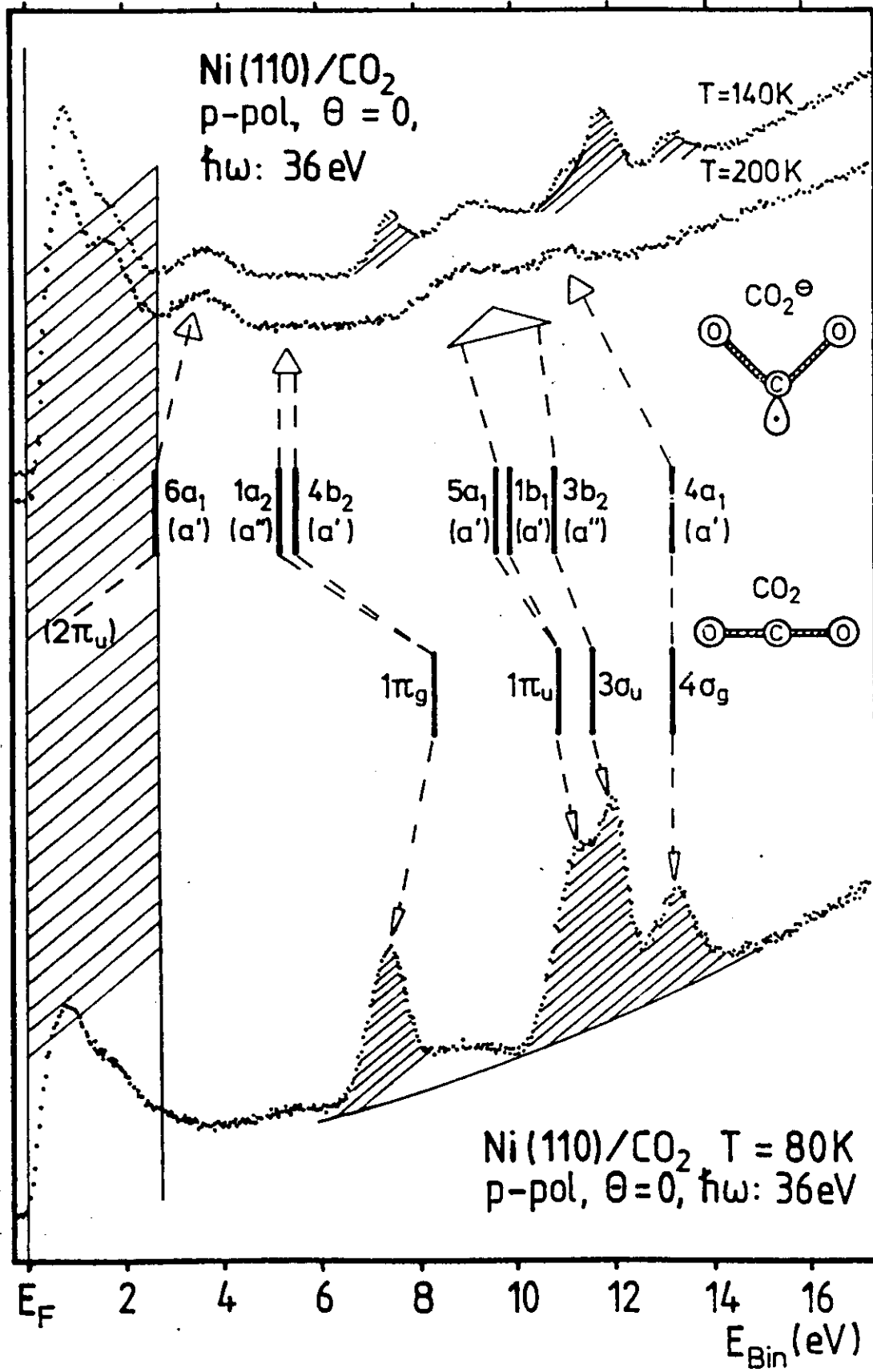
Ni

Pau MacLung
et al

Ng

1001





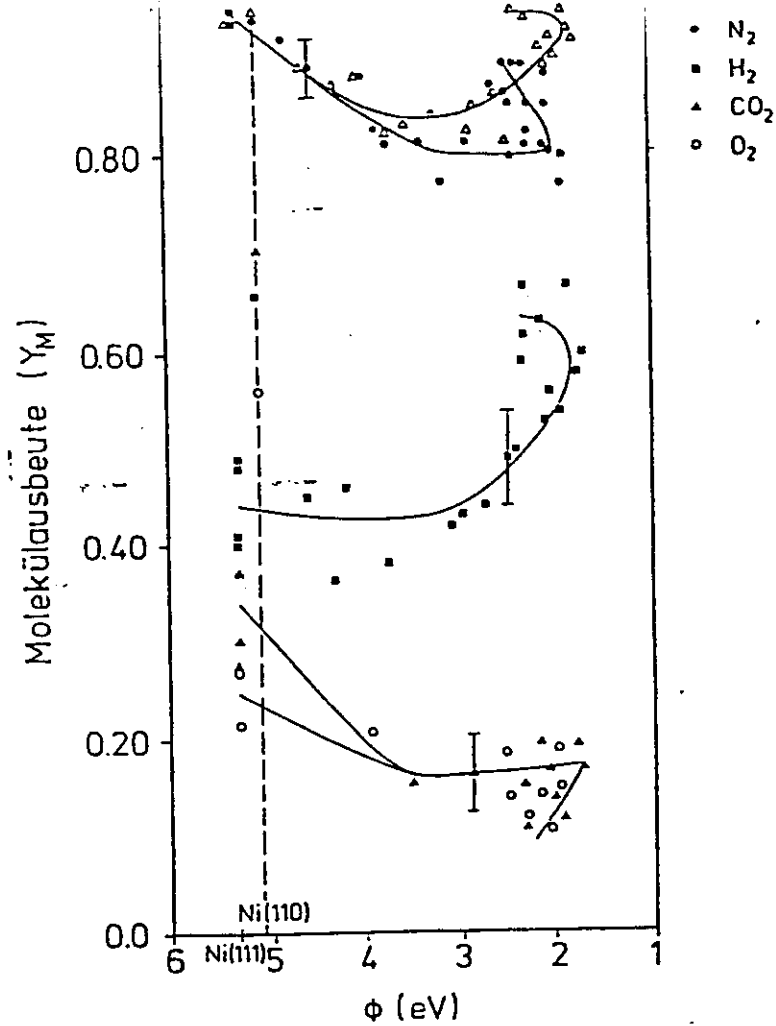


Abb. 20: Die Überlebenswahrscheinlichkeit der unterschiedlichen Molekülarten (Y_M) als Funktion der Austrittsarbeit (ϕ) der kaliumbedeckten Ni(111)-Oberfläche. Zum Vergleich sind auch die an der Ni(110)-Oberfläche erhaltenen Werte eingezeichnet.

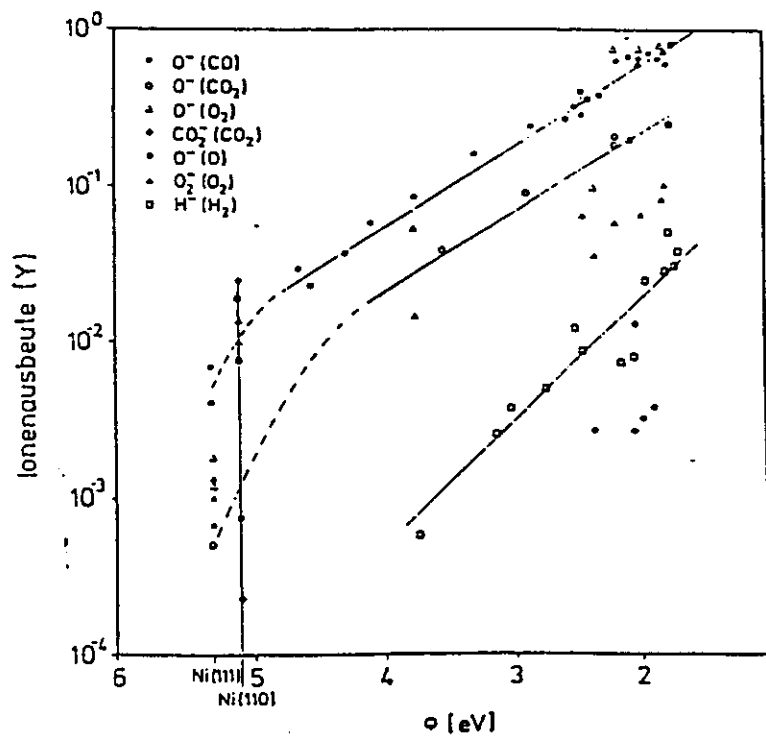


Abb. 21: Die Ionenausbeute als Funktion der Austrittsarbeit der kaliumbedeckten Ni(111)-Oberfläche. Zum Vergleich sind auch die an der Ni(110)-Oberfläche erhaltenen Werte eingezeichnet.

